# FCC TAS validation – Part 2: Tests under dynamic transmit power scenarios

FCC ID : A4RG4QUR

Equipment : Phone

Model Name : G4QUR

Applicant : Google LLC

1600 Amphitheatre Parkway, Mountain View, CA, 94043 USA Report No.: FA4N0917C

**Standard** : FCC 47 CFR Part 2 (2.1093)

The product was received on Jan. 15, 2025 and testing was started from Feb. 19, 2025 and completed on Mar. 31, 2025. We, SPORTON INTERNATIONAL INC., would like to declare that the tested sample provide by manufacturer and the test data has been evaluated in accordance with the test procedures given in 47 CFR Part 2.1093 and FCC KDB and has been pass the FCC requirement.

The test results in this report apply exclusively to the tested model / sample. Without written approval of SPORTON INTERNATIONAL INC. EMC & Wireless Communications Laboratory, the test report shall not be reproduced except in full.

Approved by: Cona Huang / Deputy Manager

Cona Guang

Sporton International Inc. Wensan Laboratory

No.58, Aly. 75, Ln. 564, Wenhua 3rd, Rd., Guishan Dist., Taoyuan City 333010, Taiwan

TEL: 886-3-327-3456 Page: 1 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# **Table of Contents**

Report No.: FA4N0917C

1. Introduction	
2. Tx Varying Transmission Test Cases and Test Proposal	4
3. SAR Time Averaging Validation Test Procedures	5
3.1 Test sequence determination for validation	5
3.2 Test configuration selection criteria for validating TAS	5
3.3 Test procedures for conducted power measurements	5
4. NTN SAR Time Averaging Validation Test Procedures	8
5. Spatial TAS	
6. PD Time Averaging Validation Test Procedures	10
6.1 Test sequence determination for validation	10
6.2 Test configuration selection criteria for validating TAS	10
6.3 Test procedures for FR2 radiated power measurements	
7. Test Configurations	
7.1 WWAN (sub-6) transmission	
7.2 Test case list for sub-6GHz transmissions	
7.3 Test case list for LTE+FR2 transmissions	
8. Conducted Power Test Results for Sub-6 and NTN TAS validation	
8.1 Measurement set-up	
8.2 NTN Measurement set-up	
8.3 Measured Plimit and Pmax	
8.4 Sub-6 summary test results	22
8.5 Time-varying Tx power measurement results	
8.6 Change in Power Index	
8.7 Change in call test results	
8.8 Switch in SAR exposure test results	
8.9 Re-selection in call test results	
8.10 LTE Uplink CA	
8.11 NTN with time-varying startup test sequence	
9. FR2 Radiated power Test Results for TAS validation	
9.1 Measurement setup	
9.2 Time-varying Tx power measurement results	
9.3 SAR vs. PD exposure switch	
9.4 FR2 beam change	
9.5 NR Dual Connectivity	
10. Conclusions	
11. Annex	
11.1 Test sequence is generated based on below parameters of the DUT:	
11.2 Test Sequence A waveform:	
11.3 Test Sequence B waveform:	
12. Test Equipment List	70

# **Appendix A. Test Setup Photos**

# History of this test report

Report No.: FA4N0917C

Report No.	Version	Description	Issued Date
FA4N0917C	01	Initial issue of report	Apr. 08, 2025
FA4N0917C	02	Update section 7.1	Apr. 17, 2025
FA4N0917C	03	Update section 7.3	Apr. 21, 2025

TEL: 886-3-327-3456 Page: 3 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 1. Introduction

This purpose of this Part 2 report is to demonstrate that the DUT complies with FCC RF exposure compliance requirement under varying Tx power transmission scenarios, thus validating the Samsung S.LSI proprietary Spatial Time Average SAR (S-TAS) with Non-Terrestrial Networks algorithm\_ForOEM\_v.2.8 for RF Exposure equipment authorization of the handset. The values of Plimit used in this report per scenario are determined in Part 0 report.

Report No.: FA4N0917C

# 2. Tx Varying Transmission Test Cases and Test Proposal

The following scenarios are covered in this report to demonstrate compliance with FCC RF exposure in Tx varying transmission conditions.

- 1. During a time-varying Tx power transmission to prove that TAS feature accounts for Tx power variations in time accurately.
- 2. During a call disconnect and re-establish scenario to prove that the TAS feature accounts for history of Tx power from past accurately
- 3. During a technology/band handover to prove that TAS feature accounts for history across transitions in band/technology
- 4. During operating state change to prove that TAS feature functions correctly to meet compliance limits across operate state changes
- 5. During time averaging window change to prove that TAS feature properly handles the change from one time averaging window to another as specified by FCC, and meets the normalized FCC limit of 1.0 at all time

As described in Part 0, the RF exposure is proportional to the Tx power for sub-6. Thus, we rely on conducted power measurements (sub-6) in each dynamic case to demonstrate that overall RF exposure is within the FCC limit.

The overall procedure for validating the test is summarized below:

- 1. Measure conducted power over time, denoted as TxPower(t), with time index t for each radio
- Convert measured powers to RF exposure values using linear relationship shown below. In below expression, Pimit,sub-6 would be the measured power at which FR1 technology meets measured SAR level of SAR\_design\_target as described in Part 0.

$$SAR(t) = \frac{TxPower(t)}{Plimit.sub-6} * SAR\_design\_target$$
 (2.1.1)

- 3. Compute the average RF exposure over the most recent measurement duration which are denoted as TSAR for sub6 . These durations are as specified by FCC. This measurement duration interval is then given by [t TSAR, t] for sub-6.
- 4. Divide the RF exposure by corresponding FCC limit and ensure the sum denoted as TER (total exposure ratio) is less than 1 for all. The following equation describes the calculation of TER and its target constraint. *LSAR* is the number of fixed, mobile or portable RF sources using SAR-based formula, the expressions below is general considering a number radios in general denoted by *LSAR*.

$$\sum_{ISAR=0}^{LSAR-1} \frac{SARavr, ISAR}{FCC SAR} \le 1$$
 (2.1.3)

TEL: 886-3-327-3456 Page: 4 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 3. SAR Time Averaging Validation Test Procedures

Test plan and test procedure for validating Samsung SLSI TAS feature for sub-6 scenarios

## 3.1 Test sequence determination for validation

Two sequences for time varying Tx power are pre-defined as given below for sub-6 case.

1. Test Sequence A is generated with two power levels. One is maximum power level Pmax and the other is lower power level. The lower power level is defined as 3dB lower value than maximum power level. At first, maximum power level is applied for 80 seconds. After this, lower power level is used until this test is finished.

Report No.: FA4N0917C

Test Sequence B is generated at multiple power levels that are specified in the Appendix as a function of Pmax and Plimit.

## 3.2 Test configuration selection criteria for validating TAS

This section provides general guidance for selecting test cases in TAS feature validation.

#### 3.2.1 Test configuration selection for time-varying Tx power transmission

The Samsung S.LSI TAS algorithm is independent of band, modes or channel of any technology. Hence, we can validate using one or two combinations of band/mode/channel per technology. The criteria for selecting these would be based on the relative value of Plimit and Pmax as determined in Part 0. Essentially, we need to pick this combination such that Plimit is less than Pmax so that the TAS algorithm will enforce power restriction. Two bands can be selected from Part 0 with different values of Plimit -select one corresponding to lowest Plimit and another being highest but still less than Pmax.

#### 3.2.2 Test configuration selection for change in call

The criteria to select the technology/band for transition between call setup and call drop is to choose the one with least Plimit among all bands in Part 0. The test is performed with DUT requested power at Pmax so that the Samsung S.LSI TAS feature enforces power restriction for longest duration. The call change is performed when the DUT is operating with restricted power. One such test is sufficient since behavior is not dependent on band/technology.

# 3.2.3 Test configuration for change in technology/band/window

FCC specifies different measurement durations for time averaging based on operating frequency. The change of operating frequency can result in change of time window for averaging, for e.g. change from 100s averaging for frequency below 3GHz to 60s averaging for frequency above 3-6 GHz, The criteria for selecting test case to demonstrate compliance across time window change is to pick a technology/band corresponding to each time window from Part 0 such that Plimit is less than Pmax.

#### 3.3 Test procedures for conducted power measurements

This section provides general conducted power measurement procedures to perform compliance test under dynamic scenarios described in Section 2.

# 3.3.1 Time-varying Tx power transmission scenario

This test is performed with two pre-defined test sequences as described in Section 3.1 for all technologies operating on sub-6GHz applying to both UMTS, LTE and NR as selected in Section 3.2.1. The purpose of the test is to demonstrate the maximum power limiting enforcement and that the time-averaged SAR does not exceed the FCC limit at all times.

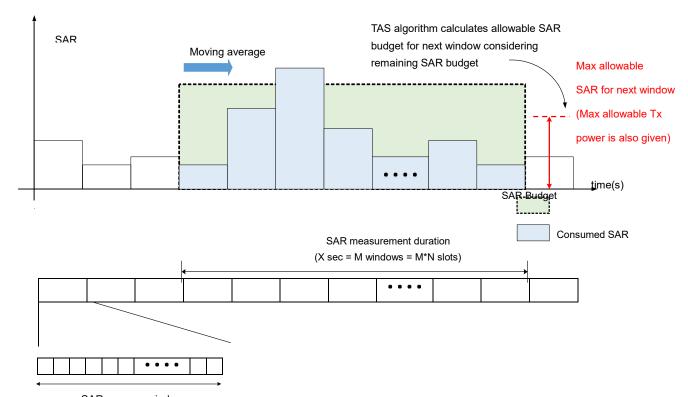
TEL: 886-3-327-3456 Page: 5 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 3.3.1.1 <u>Test procedure</u>

 Using the Pmax and Plimit obtained in Part 0/1, generate the test sequence of power levels for each selected technology/band. Both test sequences A and B are generated. Maximum power can be changed according to DUT test results.

Report No.: FA4N0917C

2. Establish the connection of the DUT to the call box in the selected RAT, with the call box requesting the DUT TX power to be according to the sequence determined in Step 1. An initial value of Tx power will be set to 0dBm for 100s before the desired test sequence starts to help with post-processing of the time-average value with the very first value in the sequence. This is illustrated in the figure below



SAR average window Average SAR value in a slot can be calculated from average Tx power in the slot (Assume that SAR vs Tx power relation is obtained from real measurement)

Figure 3.3-1 SAR measurement from Tx power using block-wise processing

- 3. Release connection.
- 4. After the completion of the test, prepare one plot with the following information:
  - a. Instantaneous Tx power versus time measured in Step 2
  - b. Requested Tx power versus time used in Step 2
  - c. Time-averaged power over 100s using instantaneous values from Step 2
  - d. Power level Plimit which is determined as meeting SAR target in Part 0/1
- 5. Make a second plot containing the following information:
  - Computed time-averaged 1gSAR versus time determined in Step 2
  - b. FCC 1gSAR limit of 1.6W/kg

The pass condition is to demonstrate time-averaged 1gSAR versus time shown in Step 5 value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. We would also demonstrate that time-averaged power does not exceed the Plimit at any time in the plot in Step 4.

TEL: 886-3-327-3456 Page: 6 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

#### 3.3.2 Change in call scenario

This test is to demonstrate that Samsung S.LSI TAS feature correctly accounts for past Tx powers during time- averaging when a new call is established. The call change has to be carried out when the power limit enforcement is ongoing.

Report No.: FA4N0917C

#### 3.3.2.1 <u>Test procedure</u>

- 1. Establish radio connection of DUT with call box e.g. using LTE technology
- 2. Configure call box to set DUT Tx power to a low value of -10dBm for 100s.
- 3. Configure call box to send "ALL UP" power control commands and continue LTE transmission from DUT so that maximum power of Pmax is achieved.
- 4. After 60s of transmission at Pmax power level, release the call from call box.
- 5. After 10s, re-establish the LTE connection from call box to DUT and repeat sending "ALL UP" power control command to bring the Tx power to Pmax level again.
- 6. Continue LTE transmission at Pmax level for another 110s.
- 7. Release LTE connection.
- 8. After the completion of the test, prepare one plot with the following information (a) Instantaneous Tx power versus time (b) Requested Tx power versus time (c) Time-averaged power over 100s using instantaneous values and (d) Power level Plimit which is determined as meeting SAR target
- 9. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time and (b) FCC 1gSAR limit of 1.6W/kg

Pass condition is to demonstrate time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if SAR calculation is accounting for call drop and connection. Current TAS algorithm software makes the UE estimate the exact amount of Tx power and average SAR even during call drop and call re-establishment event. The UE stores time information when it goes into a sleep mode and wake-up to calculate Tx power on / off duration.

#### 3.3.3 Change in technology/band/window

This test is to demonstrate that Samsung S.SLSI TAS feature can properly handle change of technology/band and consequently time window as necessary during handover scenarios. Since both Plimit and window duration can change across bands, we have to use separate equations below for converting Tx power to SAR as well as apply a combined SAR exposure criterion as shown below.

SAR 1 (t) = 
$$\frac{\text{TxPower(t)}}{\text{Plimit,sub6}} * SAR\_design\_target$$
 (3.3.1)

SAR 2 (t) = 
$$\frac{\text{TxPower(t)}}{\text{Plimit,sub6}} * SAR\_design\_target$$
 (3.3.2)

where Plimit, 1, FR1 would correspond to measured power at which first technology/band meets measured SAR level of  $SAR\_design\_target1$  as described in Part 0 and Part 1 wit time-averaging duration of T1, SAR. Similarly, Plimit, FR2 would be the measured EIRP at which FR2 technology meets measured PD level of PD  $\_design\_target$  as described in Part 0. Similarly, the quantities Plimit, 2, FR1, SAR design target2, T2, SAR are defined for the second technology/band.

## 3.3.4 Change in Power Index

This test is to demonstrate that Samsung S.LSI TAS feature can properly handle change of RSI resulting from different SAR index state detected by host platform software. It involves changing the Plimit value during the test for the same technology to emulate power index change.

## 3.3.5 Test configuration for SAR exposure switching

The criteria for selecting test case is to pick an LTE band and a NR band with Plimit lower than Pmax in each case. The test is performed with both RATs connected in an EN-DC scenario. In the first portion of the test, DUT is requested to transmit at maximum power for NR and minimum power for LTE. In the second portion of the test, DUT is requested to transmit at maximum power for both NR and LTE. In the final portion of the test, DUT is requested to transmit at minimum power for NR and maximum power for LTE.

TEL: 886-3-327-3456 Page: 7 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

#### 3.3.6 Test procedure for handover between two TAS RATs

- 1. Establish radio connection of DUT with call box e.g. using NR band
- 2. Configure call box to set DUT Tx power to a low value of 0dBm for 110s.
- 3. Configure call box to send "ALL UP" power control commands and continue NR transmission from DUT so that maximum power of Pmax is achieved. Continue transmission at the maximum power for 120s.
- 4. Change RAT from NR to LTE and configure call box to send "ALL UP" power control commands in LTE
- 5. Continue call in LTE at maximum power for 400s

#### 3.3.7 Test configuration for Uplink CA

The criteria for selecting this test case is to demonstrate the compliance of the TAS algorithm when an LTE or FR1 transmission is done over multiple CC. This test shows that the TAS algorithm compliance is independent on the Transmission scenarios (single CC or CA), select any one technology that the EUT supports to demonstrate compliance.

Report No.: FA4N0917C

# 4. NTN SAR Time Averaging Validation Test Procedures

In this Section, we cover the test plan and test procedure for validating Samsung S.LSI TAS feature for NTN scenario.

This sequence is generated with two power levels. One is a very low power and the other is maximum power level of Pmax. At first, the low power level is applied for 540 s seconds (by placing the transmission in the idle mode). After this, maximum power level is used for 540 s or more.

#### NTN with time-varying startup test sequence

- 1. Establish NTN connection of DUT with call box on NTN band
- 2. Send an RRC release to the UE so that it goes into the idle mode with no transmission and keep that state for 540 s.
- 3. Configure MAC padding in DL & UL in connected mode so that maximum power (Pmax) is achieved and continue transmission for 540 s
- 4. Release NTN connection

TEL: 886-3-327-3456 Page: 8 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 5. Spatial TAS

In legacy TAS algorithm (V2.3), it was assumed that all antennas are correlated regardless of their direction of transmission in space. Thus, the main concept was to split the SAR/TER on the transmitting RATs even they are transmitting on different antennas. Such approach is considered as a worst case scenario in terms of transmitting power. Thus, to enhance the performance of the transmission power of RATs, we should consider the spatial properties of each antenna and the correlations between the antennas transmissions. The TAS algorithm from the latest Samsung submission document revision v2.7 is implemented.

Report No.: FA4N0917C

For example, consider a DUT with two antennas one at the top and one at the bottom and each are transmitting in two different direction with no common area affected by both. For such DUT architecture, if each antenna utilize the full SAR compliance while transmitting simultaneously, then the power transmission is still under compliance since no area is affected by both transmissions and thus no area will have SAR above SAR compliance.

For a DUT with N antennas, a spatial correlation matrix (R) can be constructed to map the correlation between each two antennas when they transmit simultaneously. Thus this correlation matrix is given as

$$R = \begin{bmatrix} r_{11} & r_{12} & \dots & r_{1N} \\ r_{21} & r_{22} & \dots & r_{2N} \\ \vdots & \vdots & \ddots & \vdots \\ r_{N1} & r_{N2} & \dots & r_{NN} \end{bmatrix}$$

And it has the following characteristics

- a)  $r_{ij}$  is the correlation between antenna i and antenna j
- b) The value of  $r_{ij}$  is either 0 or 1, where 1 means fully correlated and 0 means fully uncorrelated.
- c)  $r_{ii}$  is the self-correlation of each antenna and it is always 1

For ENDC operation, the value of the correlation coefficients  $(r_{ij})$  between the two transmitting antennas (i,j) will determine the splitting ratios between the two operating RATs as follow

- a) If  $r_{ij}$  = 0 then each antenna will transmit with full SAR compliance
- b) If  $r_{ij} = 1$  then the full SAR compliance will be split among both antennas with ration a:b, where a + b = 1

Since the R matrix entries depends on the antenna distribution of each DUT, then our spatial TAS algorithm is implemented to operate with any R matrix (antenna distribution agnostic).

The values of the R matrix entries should be determined by the OEM based on the DUT used. One way to determine the values of the R matrix entries is to use the SPLSR test mentioned in FCC KDB 447498 D01, section 4.3.2.

The SPLSR test is done between each pair of antennas as follow

- i. Measure the SAR peak location for each antenna  $(x_i, y_i, z_i)$  and  $(x_j, y_j, z_j)$
- ii. Calculate  $\Gamma_{ij} = \frac{\left(SAR_{1,max} + SAR_{j,max}\right)^{1.5}}{D}$ , where  $SAR_{i,max} = SAR_{j,max} = SAR_{comp}$  and  $D = \sqrt{\left(x_i x_j\right)^2 + \left(y_i y_j\right)^2 + \left(z_i z_j\right)^2}$
- iii. Check if the value of  $\Gamma_{ij} \leq 0.04$  for 1g and 0.1 for 10g then these two antennas are considered fully uncorrelated and we can set  $r_{ij} = 0$ . Otherwise, a Volumetric SAR evaluation can be done to check the non-correlation of both antennas and if not set  $r_{ij} = 1$
- iv. If volumetric SAR cannot meet FCC SAR compliance requirements, set  $r_{ij} = 1$ .

NOTE: The antennas corresponding to the selected RSIs or change in technology/band/window should be in the rij=1 if EUT is configured Spatial TAS algorithm.

TEL: 886-3-327-3456 Page: 9 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 6. PD Time Averaging Validation Test Procedures

In this section, we cover the test plan and test procedure for validating Samsung SLSI TAS feature for FR2 scenarios. For this DUT, FR2 transmissions are only in non-standalone mode, so it requires LTE or FR1 as an anchor and both SAR for LTE/FR1 and PD for FR2 will be accounted.

Report No.: FA4N0917C

# 6.1 Test sequence determination for validation

In FR2 transmissions, the test sequence for validation is with the callbox requested maximum power for FR2 at all time.

# 6.2 Test configuration selection criteria for validating TAS

#### 5.2.1 Test configuration selection for time-varying Tx power transmission

Since the TAS feature is independent of band and beams for a given technology, demonstration with one band will be sufficient.

## 5.2.2Test configuration selection for time-varying Tx power transmission

The TAS feature works for both types of exposure (SAR or PD) and ensures total time-averaged exposure ratio meets the FCC limit of 1. One scenarios of LTE band and FR2 band time-varying Tx power verification is sufficient, while exposure condition can be varied between SAR dominant, SAR+PD scenario and PD dominant scenarios for demonstration.

#### 5.2.3 Test configuration selection for change of beam

Since the TAS feature is independent of band and beams for a given technology, demonstration with one pair of beams for switching between them will be sufficient.

TEL: 886-3-327-3456 Page: 10 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 6.3 Test procedures for FR2 radiated power measurements

For FR2 testing, we need to perform conducted power measurements for LTE and radiated power measurements for FR2. This section provides general procedures for test setup to validate the compliance in dynamic scenarios outlines in Section 2.

Report No.: FA4N0917C

#### 5.3.1 FR2 max power transmission

#### 6.3.1.1 Test procedure

- 1. Select EN-DC (LTE+FR2) or NR-DC(FR1+FR2) to demonstrate TAS validation.
- Set the phone in an anechoic chamber for FR2 radiated transmission. In a non-signaling transmission mode for FR2 at maximum target EIRP, adjust the position of the DUT via rotation within the chamber to obtain the maximum measured radiated EIRP using the fixed test antenna. Keep the DUT in this fixed position for the remainder of the test.
- 3. Reset the DUT state to normal signaling mode and establish both LTE and FR2 connections with the call box.
- 4. Immediately send "ALL DOWN" power control commands from LTE call box to send LTE to the lowest transmission power. Next, configure the FR2 call box to send "ALL UP" power control commands to send FR2 radio to maximum EIRP condition. In this case, the FR2 radio will comprise the dominant exposure condition using PD metric.
- 5. After 120s, configure LTE call box to send "ALL UP" power control commands and continue transmission.
- 6. Record the conducted power of LTE and radiated EIRP of FR2 radio at all times during the test.
- 7. After 200s, release LTE and FR2 connection.
- 8. After the end of the test, convert the instantaneous LTE Tx power into 1gSAR value using Plimit and Eqn (2.1.1), and then divide by FCC limit of 1.6W/Kg to obtain normalized SAR versus time. Perform 100s time averaging to determine normalized average 1gSAR versus time.
- 9. Similar to Step 7, convert the instantaneous radiated FR2 EIRP into PD value using Plimit and Eqn (2.1.2), and then divide by FCC limit of 10W/m<sup>2</sup> for 4cm<sup>2</sup> spatial averaging to obtain instantaneous normalized PD versus time. Perform 4s time averaging to determine normalized average PD versus time.
- Make one plot containing (a) Instantaneous conducted power for LTE, (b) computed 100s time-averaged power for LTE, (c) Instantaneous EIRP for FR2, (d) computed 4s time averaged EIRP for FR2 and (e) Plimit for each of LTE and FR2
- 11. Make a second plot containing (a) normalized 100s time-averaged SAR for LTE computed in Step 7 (b) normalized 4s time-averaged PD for FR2, (c) TER (Total Exposure Ratio) corresponding total normalized time-averaged RF exposure (using sum of 10(a) and 10(b)) versus time

Pass condition is to demonstrate that TER is kept under 1.0 throughout the test. This ensures that criteria defined in is met at all times.

TEL: 886-3-327-3456 Page: 11 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

#### 5.3.2 SAR vs PD exposure switch during transmission

This test is to ensure that Samsung S.LSI TAS feature works for any nature of exposure (SAR or PD) and accurately accounts for switching among SAR dominant, SAR+PD, and PD dominant scenarios, and ensured total time-averaged RF exposure compliance at all times.

Report No.: FA4N0917C

#### 5.3.2.1 Test procedure

- Set the DUT in an anechoic chamber for FR2 radiated transmission. In a non-signaling transmission mode for FR2 at maximum target EIRP, adjust the position of the DUT via rotation within the chamber to obtain the maximum measured radiated EIRP using the fixed test antenna. Keep the DUT in this fixed position for the remainder of the test.
- 2. Reset the DUT state to normal signaling mode and establish both LTE and FR2 connections with the call box.
- 3. Immediately send "ALL DOWN" power control commands from LTE call box to send LTE to the lowest transmission power. Next, configure the FR2 call box to send "ALL UP" power control commands to send FR2 radio to maximum EIRP condition. In this case, the FR2 radio will comprise the dominant exposure condition using PD metric.
- 4. After 120s, configure LTE call box to send "ALL UP" power control commands and continue transmission. Now, the RF exposure margin for FR2 should begin to reduce and could cause reduction in EIRP or stopping of FR2 transmissions.
- After 120s, configure LTE call box to send "ALL DOWN" power control commands and continue transmission.
   Now, the FR2 radio should begin to obtain more RF exposure margin and start its transmission at higher power again.
- 6. Record the conducted power of LTE and radiated EIRP of FR2 radio at all times during the test.
- 7. Release LTE and FR2 connection.
- After the end of the test, convert the instantaneous LTE Tx power into 1gSAR value using Plimit and Eqn (2.1.1), and then divide by FCC limit of 1.6W/Kg to obtain normalized SAR versus time. Perform 100s time averaging to determine normalized average 1gSAR versus time.
- 9. Similar to Step 7, convert the instantaneous radiated FR2 EIRP into PD value using Plimit and Eqn (2.1.2), and then divide by FCC limit of 10W/m<sup>2</sup> for 4cm<sup>2</sup> spatial averaging to obtain instantaneous normalized PD versus time. Perform 4s time averaging to determine normalized average PD versus time.
- Make one plot containing (a) Instantaneous conducted power for LTE, (b) computed 100s time- averaged power for LTE, (c) Instantaneous EIRP for FR2, (d) computed 4s time averaged EIRP for FR2 and (e) Plimit for each of LTE and FR2
- 11. Make a second plot containing (a) normalized 100s time-averaged SAR for LTE computed in Step 7 (b) normalized 4s time-averaged PD for FR2, (c) TER (Total Exposure Ratio) corresponding total normalized time-averaged RF exposure (using sum of 10(a) and 10(b)) versus time

Pass condition is to demonstrate that TER is kept under 1.0 throughout the test. This ensures that criteria defined in is met at all times.

TEL: 886-3-327-3456 Page: 12 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

#### 5.3.3 Change of beam

This test is to demonstrate that Samsung S.LSI TAS feature can account for change of beam in FR2 and still meet total RF exposure compliance.

Report No.: FA4N0917C

#### 5.3.3.1 Test procedure

- Set the DUT in an anechoic chamber for FR2 radiated transmission. In a non-signaling transmission mode for FR2 at beam of maximum target EIRP, adjust the position of the DUT via rotation within the chamber to obtain the maximum measured radiated EIRP using the fixed test antenna.
- 2. Reset the DUT state to normal signaling mode and establish both LTE and FR2 connections with the call box.
- 3. Immediately send "ALL DOWN" power control commands from LTE call box to send LTE to the lowest transmission power. Next, configure the FR2 call box to send "ALL UP" power control commands to send FR2 radio to maximum EIRP condition. In this case, the FR2 radio will comprise the dominant exposure condition using PD metric.
- 4. After 20s, the test equipment turns the DUT by 30 degrees (horizontal=30, vertical=0) to change best module and correspondingly a beam change.
- 5. After 20s, the test equipment turns the DUT by 60 degrees (horizontal=60, vertical=0) to change best module again and correspondingly a beam change.
- 6. Continue the LTE and FR2 transmissions for another 20s
- Record the conducted power of LTE and radiated EIRP of FR2 radio and per beam at all times during the test.
- 8. Release LTE and FR2 connection.
- After the end of the test, convert the instantaneous LTE Tx power into 1gSAR value using Plimit and Eqn (2.1.1), and then divide by FCC limit of 1.6W/Kg to obtain normalized SAR versus time. Perform 100s time averaging to determine normalized average 1gSAR versus time.
- 10. Similar to Step 9, convert the instantaneous radiated FR2 EIRP into PD value using Plimit and Eqn (2.1.2), and then divide by FCC limit of 10W/m<sup>2</sup> for 4cm<sup>2</sup> spatial averaging to obtain instantaneous normalized PD versus time for each beam. Perform 4s time averaging to determine normalized average PD versus time. Note that for each beam, we have to use the corresponding Plimit values before converting to the PD values.
- 11. Make one plot containing (a) Instantaneous conducted power for LTE, (b) computed 100s time- averaged power for LTE, (c) Instantaneous EIRP for FR2 per beam, (d) computed 4s time averaged EIRP for FR2 per beam and (e) Plimit for each of LTE and FR2
- 12. Make a second plot containing (a) normalized 100s time-averaged SAR for LTE computed in Step 7 (b) normalized 4s time-averaged PD for FR2 per beam, (c) TER (Total Exposure Ratio) corresponding total normalized time-averaged RF exposure (using sum of 12(a) and 12(b)) versus time as computed in left hand side of equation below

Pass condition is to demonstrate time-averaged 1gSAR value and 4cm2 PD versus time does not exceed the FCC limits of 1.6 W/kg and 10W/m2 throughout the test duration. And TER (Total Exposure Ratio) as in Eqn should be kept under 1.0 throughout the test. It is required to check if power limiting enforcement is operated as expected during the test.

TEL: 886-3-327-3456 Page: 13 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

#### 5.3.4 NR Dual Connectivity (NR-DC)

This test is to ensure that Samsung S.LSI TAS feature works for simultaneous different nature of exposure (SAR+PD) from FR1 and FR2. The test shows that the algorithm ensures a total time-averaged RF exposure compliance at all times.

Report No.: FA4N0917C

#### 5.3.4.1 Test Procedure

- Set the phone in an anechoic chamber for FR2 radiated transmission. In a non-signaling transmission mode
  for FR2 at maximum target EIRP, adjust the position of the DUT via rotation within the chamber to obtain the
  maximum measured radiated EIRP using the fixed test antenna. Keep the DUT in this fixed position for the
  remainder of the test
- 2. Reset the DUT state to normal signaling mode and establish both FR1 and FR2 connections with the call box.
- Configure NR FR2 connections call box to send "Target -10dBm" power control commands to send FR2 radio
  to maximum EIRP condition while configuring NR FR1 connections call box to send "Target -10dBm" power
  control commands. Continue Transmission for 120s
- 4. Configure NR FR2 connections call box to send "ALL UP" power control commands to send FR2 radio to maximum EIRP condition while configuring NR FR1 connections call box to send "Target -10dBm" power control commands. Continue Transmission for 150s 5. Configure NR FR1 connections call box to send "ALL UP" power control commands to request the maximum power (Pmax). Continue Transmission for at least 300s.
- 5. Release both connections

TEL: 886-3-327-3456 Page: 14 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 7. Test Configurations

# 7.1 WWAN (sub-6) transmission

- 1 The Plimit values correspond to SAR design target.
- 2 GSM doesn't support time average feature of dynamic power varying, the power will be fixed at the static reduce power level at different exposure conditions for RF exposure compliance. For the GSM Plimit power levels in the table correspond to the burst average power levels which don't account for TX duty cycle.

Report No.: FA4N0917C

- 3 UMTS, LTE, FR1 and NTN: Plimit power levels in the table correspond to the time-averaged power levels which accounts for TX duty cycle.
- 4 Maximum target power, Pmax, is configured in NV settings in EUT to limit maximum transmitting power. This power is converted into peak power in NV settings for TDD schemes.

Table 6.1.1:  $P_{limit}$  for supported technologies and bands ( $P_{limit}$  corresponding to SAR design target)

Tuble 0.1	.1: Plimit TOT'S	apported to		Maximum	1	ead	Hotspot		n/Extremity			
Wireless technology				Power Condition	Standalone	Simultaneous	Simultaneous	Standalone	Simultaneous	P Max Burst		
(No Accounting	Mode	Duty Cycle %	Antenna	Index 1	Index 2	Index 3	Index 4	Index 5	Index 6	average		
duty cycle)		70		P limit								
				Burst average power (dBm)								
	GSM/GPRS 1TX	12.50%		32.50	34.20	33.00	32.80	34.10	33.40	32.50		
	GPRS 2TX	25.00%		31.50	31.20	30.00	29.80	31.10	30.40	31.50		
	GPRS 3TX	37.50%		30.50	29.40	28.20	28.00	29.30	28.60	30.50		
GSM850	GPRS 4TX	50.00%	A == 40	29.50	28.20	27.00	26.80	28.10	27.40	29.50		
G2101630	EDGE 1TX	12.50%	Ant0	26.50	34.20	33.00	32.80	34.10	33.40	26.50		
	EDGE 2TX	25.00%		25.50	31.20	30.00	29.80	31.10	30.40	25.50		
	EDGE 3TX	37.50%		24.50	29.40	28.20	28.00	29.30	28.60	24.50		
	EDGE 4TX	50.00%		23.50	28.20	27.00	26.80	28.10	27.40	23.50		
	GSM/GPRS 1TX	12.50%		32.30	31.30	30.10	35.60	36.30	35.60	32.30		
	GPRS 2TX	25.00%		31.30	28.30	27.10	32.60	33.30	32.60	31.30		
	GPRS 3TX	37.50%	- Ant1 -	30.30	26.50	25.30	30.80	31.50	30.80	30.30		
GSM850	GPRS 4TX	50.00%		29.30	25.30	24.10	29.60	30.30	29.60	29.30		
GOINIGOU	EDGE 1TX	12.50%		26.30	31.30	30.10	35.60	36.30	35.60	26.30		
	EDGE 2TX	25.00%		25.30	28.30	27.10	32.60	33.30	32.60	25.30		
	EDGE 3TX	37.50%		24.30	26.50	25.30	30.80	31.50	30.80	24.30		
	EDGE 4TX	50.00%		23.30	25.30	24.10	29.60	30.30	29.60	23.30		
	GSM/GPRS 1TX	12.50%		29.50	36.00	35.30	29.50	30.30	29.60	29.50		
	GPRS 2TX	25.00%		28.00	33.00	32.30	26.50	27.30	26.60	28.00		
	GPRS 3TX	37.50%		27.50	31.20	30.50	24.70	25.50	24.80	27.50		
GSM1900	GPRS 4TX	50.00%	Ant2	26.50	30.00	29.30	23.50	24.30	23.60	26.50		
G3W1900	EDGE 1TX	12.50%	AIILZ	25.50	36.00	35.30	29.50	30.30	29.60	25.50		
	EDGE 2TX	25.00%		24.50	33.00	32.30	26.50	27.30	26.60	24.50		
	EDGE 3TX	37.50%		23.50	31.20	30.50	24.70	25.50	24.80	23.50		
	EDGE 4TX	50.00%		22.50	30.00	29.30	23.50	24.30	23.60	22.50		
	GSM/GPRS 1TX	12.50%		29.10	44.20	43.50	26.30	27.70	27.00	29.10		
	GPRS 2TX	25.00%		27.60	41.20	40.50	23.30	24.70	24.00	27.60		
	GPRS 3TX	37.50%		27.10	39.40	38.70	21.50	22.90	22.20	27.10		
GSM1900	GPRS 4TX	50.00%	Ant∩	26.10	38.20	37.50	20.30	21.70	21.00	26.10		
	EDGE 1TX	12.50%	Ant0	25.10	44.20	43.50	26.30	27.70	27.00	25.10		
	EDGE 2TX	25.00%		24.10	41.20	40.50	23.30	24.70	24.00	24.10		
	EDGE 3TX	37.50%		23.10	39.40	38.70	21.50	22.90	22.20	23.10		
	EDGE 4TX	50.00%		22.10	38.20	37.50	20.30	21.70	21.00	22.10		

TEL: 886-3-327-3456 Page: 15 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



# FCC RF Exposure Report

				Maximum	Head		Hotspot	Body-wor	Body-worn/Extremity		
Wireless technology				Power Condition	Standalone	Simultaneous			Simultaneous	P Max	
(Accounting duty	Mode	Duty Cycle	Antenna	Index 1	Index 2	Index 3	Index 4	Index 5	Index 6	Time- average	
cycle)		%					imit			power (dBm)	
						Time-average	e power (dBm)			(abiii)	
WCDMA B2	R99	100.00%	Ant2	24.00	25.50	24.80	20.80	21.50	20.80	24.00	
WCDMA B2	R99	100.00%	Ant0	23.60	35.70	35.00	16.80	19.90	19.20	23.60	
WCDMA B4	R99	100.00%	Ant2	24.00	25.60	24.90	20.80	21.50	20.80	24.00	
WCDMA B4	R99	100.00%	Ant0	23.60	34.00	33.30	18.00	20.20	19.50	23.60	
WCDMA B5	R99	100.00%	Ant0	24.30	27.80	27.10	23.70	25.60	24.90	24.30	
WCDMA B5	R99	100.00%	Ant1	24.00	20.90	19.70	25.70	26.40	25.70	24.00	
LTE B7	PC3	100.00%	Ant2	24.10	23.60	22.40	19.00	19.70	19.00	24.10	
LTE B7	PC3	100.00%	Ant0	23.80	31.50	30.80	18.00	20.30	19.60	23.80	
LTE B12/B17	PC3	100.00%	Ant0	24.30	28.90	28.20	25.30	26.00	25.30	24.30	
LTE B12/B17 LTE B13	PC3	100.00%	Ant1	24.00 24.30	22.30	21.40 27.10	27.20 23.50	27.90	27.20 25.30	24.00	
LTE B13	PC3 PC3	100.00%	Ant0	24.00	27.80 21.50	20.30	27.00	26.00 27.70	27.00	24.00	
LTE B13	PC3	100.00%	Ant1 Ant0	24.00	28.20	27.50	24.00	26.30	25.60	24.00	
LTE B14	PC3	100.00%	Ant1	24.00	21.70	20.50	26.40	27.10	26.40	24.00	
LTE B25/B2	PC3	100.00%	Ant2	24.00	25.90	25.20	20.30	21.00	20.30	24.00	
LTE B25/B2	PC3	100.00%	Ant0	23.60	35.40	34.70	16.80	19.70	19.00	23.60	
LTE B25/B2	PC3	100.00%	Ant1	24.00	15.80	15.10	21.00	21.70	21.00	24.00	
LTE B25/B2	PC3	100.00%	Ant5	23.70	17.30	16.10	21.40	22.90	22.20	23.70	
LTE B26/B5	PC3	100.00%	Ant0	24.30	28.10	27.40	23.70	25.00	24.30	24.30	
LTE B26/B5	PC3	100.00%	Ant1	24.00	21.40	20.20	25.70	26.40	25.70	24.00	
LTE B30	PC3	100.00%	Ant2	21.60	21.60	20.90	19.60	20.30	19.60	21.60	
LTE B30	PC3	100.00%	Ant0	20.60	34.80	34.10	18.40	19.90	19.20	20.60	
LTE B41/B38	PC3	63.30%	Ant2	22.10	22.40	21.20	20.60	21.30	20.60	22.10	
LTE B41/B38	PC2	43.30%	Ant2	22.40	22.40	21.20	20.60	21.30	20.60	22.40	
LTE B41/B38	PC3	63.30%	Ant0	21.60	30.20	29.50	18.10	20.80	20.10	21.60	
LTE B41/B38	PC2	43.30%	Ant0	21.90	30.20	29.50	18.10	20.80	20.10	21.90	
LTE B48	PC3	63.30%	Ant6	17.80	28.10	27.40	19.20	19.90	19.20	17.80	
LTE B48	PC3	63.30%	Ant7	17.80	28.00	27.30	19.60	20.30	19.60	17.80	
LTE B66/B4	PC3	100.00%	Ant2	24.00	26.60	25.90	20.70	21.40	20.70	24.00	
LTE B66/B4 LTE B66/B4	PC3 PC3	100.00% 100.00%	Ant0 Ant1	23.60 24.00	34.40 16.60	33.70 15.80	18.30 22.00	19.80 22.70	19.10 22.00	23.60	
LTE B66/B4	PC3	100.00%	Ant5	23.70	16.10	14.90	21.20	22.70	22.00	23.70	
LTE B71	PC3	100.00%	Ant0	24.30	29.30	28.60	26.50	27.20	26.50	24.30	
LTE B71	PC3	100.00%	Ant1	24.00	23.30	22.20	27.50	28.20	27.50	24.00	
FR1 n7	PC3	100.00%	Ant2	24.10	22.50	21.30	19.20	19.90	19.20	24.10	
FR1 n7	PC3	100.00%	Ant0	23.80	30.50	29.80	17.00	20.00	19.30	23.80	
FR1 n12	PC3	100.00%	Ant0	24.30	28.70	28.00	25.80	26.50	25.80	24.30	
FR1 n12	PC3	100.00%	Ant1	24.00	22.10	21.10	27.40	28.10	27.40	24.00	
FR1 n14	PC3	100.00%	Ant0	24.30	28.10	27.40	25.90	26.70	26.00	24.30	
FR1 n14	PC3	100.00%	Ant1	24.00	21.60	20.70	26.50	27.20	26.50	24.00	
FR1 n25/n2	PC3	100.00%	Ant2	24.00	25.50	24.80	20.10	20.80	20.10	24.00	
FR1 n25/n2	PC3	100.00%	Ant0	23.60	36.70	36.00	17.20	19.50	18.80	23.60	
FR1 n25/n2	PC3	100.00%	Ant1	24.00	15.60	14.90	20.60	21.30	20.60	24.00	
FR1 n25/n2	PC3	100.00%	Ant5	23.70	17.30	16.10	20.90	22.40	21.70	23.70	
FR1 n26/n5	PC3	100.00%	Ant0	24.30	27.50	26.80	25.10	25.90	25.20	24.30	
FR1 n26/n5	PC3	100.00%	Ant1	24.00	20.90	19.70	26.40	27.10	26.40	24.00	
FR1 n30	PC3	100.00%	Ant2	21.60	24.60	23.90	19.60	20.30	19.60	21.60	
FR1 n30	PC3	100.00%	Ant0	20.30	34.80	34.10	18.70	20.20	19.50	20.30	
FR1 n41/n38 FR1 n41	PC3 PC2	100.00% 50.00%	Ant2 Ant2	24.10	22.60 22.60	21.40 21.40	20.60	21.30 21.30	20.60	24.10	
FR1 n41	PC2 PC1.5	25.00%	Ant2	19.50	22.60	21.40	20.60	21.30	20.60	19.50	
FR1 n41/n38	PC1.5	100.00%	Ant0	23.60	30.50	29.80	18.60	20.70	20.00	23.60	
FR1 n41	PC2	50.00%	Ant0	22.50	30.50	29.80	18.60	20.70	20.00	22.50	
FR1 n41	PC1.5	25.00%	Ant0	19.00	30.50	29.80	18.60	20.70	20.00	19.00	
<u> </u>	101.5	23.00 /6	AIIU	13.00	30.30	23.00	10.00	20.70	20.00	13.00	

Report No.: FA4N0917C

TEL: 886-3-327-3456 Page: 16 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



# FCC RF Exposure Report

FR1 n41/n38	PC3	100.00%	Ant1	24.10	13.80	13.10	18.90	19.90	19.20	24.10
FR1 n41	PC2	50.00%	Ant1	23.00	13.80	13.10	18.90	19.90	19.20	23.00
FR1 n41	PC1.5	25.00%	Ant1	19.50	13.80	13.10	18.90	19.90	19.20	19.50
FR1 n41/n38	PC3	100.00%	Ant5	23.70	17.50	16.30	20.90	22.40	21.70	23.70
FR1 n41	PC2	50.00%	Ant5	22.60	17.50	16.30	20.90	22.40	21.70	22.60
FR1 n41	PC1.5	25.00%	Ant5	19.10	17.50	16.30	20.90	22.40	21.70	19.10
FR1 n48	PC3	100.00%	Ant6	19.80	25.50	24.80	19.90	20.60	19.90	19.80
FR1 n48	PC3	100.00%	Ant7	19.80	26.50	25.80	18.40	19.10	18.40	19.80
FR1 n48	PC3	100.00%	Ant1	21.40	16.30	15.10	17.90	18.60	17.90	21.40
FR1 n48	PC3	100.00%	Ant5	22.60	15.20	14.00	21.30	22.00	21.30	22.60
FR1 n66	PC3	100.00%	Ant2	24.00	26.60	25.90	20.30	21.00	20.30	24.00
FR1 n66	PC3	100.00%	Ant0	23.60	34.00	33.30	18.10	19.90	19.20	23.60
FR1 n66	PC3	100.00%	Ant5	23.70	16.80	15.60	21.70	22.90	22.20	23.70
FR1 n66	PC3	100.00%	Ant1	24.00	16.50	15.30	21.60	22.30	21.60	24.00
FR1 n70	PC3	100.00%	Ant2	23.70	27.10	26.40	21.10	21.80	21.10	23.70
FR1 n70	PC3	100.00%	Ant0	23.30	33.30	32.60	18.00	19.70	19.00	23.30
FR1 n71	PC3	100.00%	Ant0	24.30	29.30	28.60	26.20	26.90	26.20	24.30
FR1 n71	PC3	100.00%	Ant1	24.00	23.30	22.10	28.80	29.50	28.80	24.00
FR1 n77/n78	PC3	100.00%	Ant6	24.00	22.30	21.10	17.60	18.30	17.60	24.00
FR1 n77/n78	PC2	50.00%	Ant6	23.00	22.30	21.10	17.60	18.30	17.60	23.00
FR1 n77	PC1.5	25.00%	Ant6	19.50	22.30	21.10	17.60	18.30	17.60	19.50
FR1 n77/n78	PC3	100.00%	Ant7	23.20	23.50	22.30	17.40	18.10	17.40	23.20
FR1 n77/n78	PC2	50.00%	Ant7	22.20	23.50	22.30	17.40	18.10	17.40	22.20
FR1 n77	PC1.5	25.00%	Ant7	18.70	23.50	22.30	17.40	18.10	17.40	18.70
FR1 n77/n78	PC3	100.00%	Ant1	24.00	14.60	13.40	17.20	18.70	18.00	24.00
FR1 n77	PC2	50.00%	Ant1	23.00	14.60	13.40	17.20	18.70	18.00	23.00
FR1 n77	PC1.5	25.00%	Ant1	19.40	14.60	13.40	17.20	18.70	18.00	19.40
FR1 n77/n78	PC3	100.00%	Ant5	22.60	15.80	14.60	20.70	21.40	20.70	22.60
FR1 n77	PC2	50.00%	Ant5	21.60	15.80	14.60	20.70	21.40	20.70	21.60
FR1 n77	PC1.5	25.00%	Ant5	18.70	15.80	14.60	20.70	21.40	20.70	18.70
NTN B23	PC3	83.00%	Ant1	21.70				21.10		21.70
NTN B255	PC3	83.00%	Ant4	22.70				21.60		22.70

Report No.: FA4N0917C

TEL: 886-3-327-3456 Page: 17 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 7.2 Test case list for sub-6GHz transmissions

To validate TAS algorithm in various sub-6GHz conditions, the chosen TC (Test Case) list is defined as in Table 6.2.1.

Table 6.2.1 Sub-6GHz TAS validation test case list

Report No.: FA4N0917C

No.	Test Scenario	Test case	Test configuration
1		LTE_Time_Varying_Tx_Power_Case_1	WCDMA B2
2		LTE_Time_Varying_Tx_Power_Case_1	WCDMA B4
3	Time-varying Tx power	LTE_Time_Varying_Tx_Power_Case_1	LTE B25/B2
4	transmission	LTE_Time_Varying_Tx_Power_Case_1	LTE B66/B4
5		SA_FR1_Time_Varying_Tx_Power_Case_1	n30 (SA Mode)
6		SA_FR1_Time_Varying_Tx_Power_Case_1	n41/n38 pc3 (SA Mode)
7		LTE_Time_Varying_Tx_Power_Case_2	WCDMA B2
8		LTE_Time_Varying_Tx_Power_Case_2	WCDMA B4
9	Time-varying Tx power	LTE_Time_Varying_Tx_Power_Case_2	LTE B25/B2
10	transmission	LTE_Time_Varying_Tx_Power_Case_2	LTE B66/B4
11		SA_FR1_Time_Varying_Tx_Power_Case_2	n30 (SA Mode)
12		SA_FR1_Time_Varying_Tx_Power_Case_2	n41/n38 pc3 (SA Mode)
13	Change operate states	SA_FR1_RF_SAR_Index_Change	n41/n38 pc3 (SA Mode) index 5 to Index 3
14	Drop call	Call_Disconnect_Reestablishment	LTE B25/B2
15	SAR exposure switch	NSA_FR1_Dominant_Power_Switching	LTE B48 , n25/n2 (NSA Mode)
16	Re-selection in call	NR_TO_LTE_IRAT_HO	n7 (SA Mode) to LTE B48
17	UL CA	-	LTE B7
18	NTN with time-varying startup test sequence	NTN_Time_Varying_Startup_sequence	NTN Band 23

#### Remark:

- 1. (\*)The same Plimit value is applied for all modulation schemes associated with a specific communication technology.
- 2. Correlation matrix for Spatial TAS implementation for WWAN antenna pairs, UL MIMO antenna operating on different antenna groups, therefore TAS validation is not required.

Antonno Croun	AG0	AG1	AG2
Antenna Group	Ant 0, Ant 6	Ant 1, Ant 5	Ant 2, Ant 7

Uplink MIMO antenna combination

N77//N78/N48	N77//N78/N48 Ant 6+1		Ant 7+1	Ant 7+5	
N41	Ant 2+1	Ant 2+5	Ant 0+1	Ant 0+5	

# 7.3 Test case list for LTE+FR2 transmissions

To validate TAS algorithm in scenarios including FR2, the chosen TC (Test Case) list is defined as in Table 6.3.1.

Table 6.3.1 mmWave TAS validation test case list

	Tubic 0.0	Illinivave iko vandation test	case list				
No.	Test Scenario	Test case	Test configuration				
1	Time-varying Tx power transmission	mmWave_Max_Tx_Power	LTE B2 + n258 Plane B Beam 1				
2	SAR exposure switch	mmWave_Dominant_Power_Switching	LTE B2 + n258 Plane B Beam 1				
3	Change of beam	mmWave_Module_Beam_Change	LTE B2 + n258 (Beam 1 to Beam 2 to Beam 1)				
4	NR_DC	mmWave_NR_DC	NR FR1 B25 + n258 Plane B Beam 1				

TEL: 886-3-327-3456 Page: 18 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 8. Conducted Power Test Results for Sub-6 and NTN TAS validation

Report No.: FA4N0917C

## 8.1 Measurement set-up

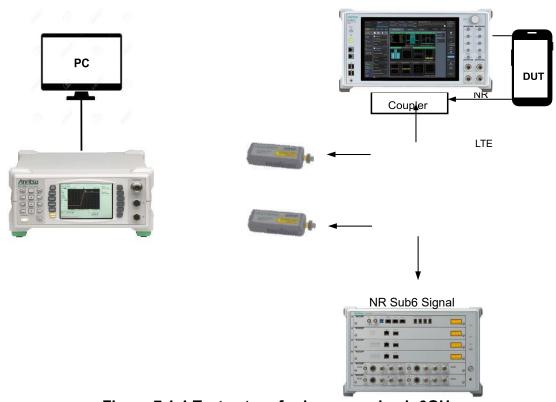


Figure 7.1-1 Test set-up for legacy and sub 6GHz

The test setup for TAS validation with sub-6GHz RATs only is shown in Figure 7.1-1.

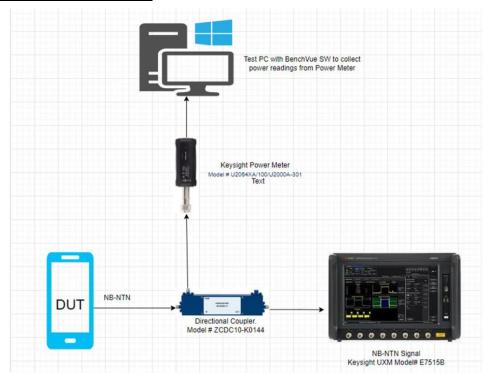
Power readings for each active technology are recorded every 100ms and dumped in an excel file. A post- processing tool is used to extract data from the excel file and plot the required metrics such as time-averaged power, SAR and TER values versus time as described in Section 3.3.

In summary, the tests have to be executed as following procedure.

- 1. Measure conduction sub 6GHz Tx power corresponds to SAR regulation.
- 2. Execute time-varying test scenarios. And record sub 6GHz power using sub 6GHz power meter equipment.
- 3. The time interval between subsequent conducted power measurements is 0.1s (typically much less than 1 second)
- 4. Plot the recorded results over measurement time. And evaluate the results for validation.
- 5. The required Power level is burst average power level controlled by call box, the power varying measurement correspond to time-average power levels after accounting for duty cycle in the case TDD modulation schemes (e.g. LTE, 5G FR1 TDD bands).

TEL: 886-3-327-3456 Page: 19 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 8.2 NTN Measurement set-up



Report No.: FA4N0917C

Figure 7.2-1 Test set-up for NTN transmission

The test setup for TAS validation for NTN is shown in Figure 7.2-1. Normally, a power meter sensor would measure total power in the entire frequency of its specification e.g. 10MHz to 40GHz for the U2064XA unit. A common power meter is able to display and record the readings for each sensor at the same time for postprocessing at a PC. The signaling call box Keysight E7515B is used to establish the call and data connection to the DUT for NB-NTN. The couplers are able to provide the transmit signal from DUT to power sensors while uplink and downlink signaling messages exchanged with the call box on the same path. A script is designed using a Keysight software called "Test App" that enables the DUT to establish an NBNTN connection with maximum power configured in the system information message.

All the path losses from RF port of DUT to the callbox and the power meters are calibrated and automatically entered as offsets in the callbox and power meter, which are also connected to the control PC used in the test setup. The Keysight software (Test App) is used to save the required configuration in the form of a script (.scpi file) which can be utilized for multiple test runs if required. Another Keysight software called "BenchVue" is used to collect readings from the power meter every 100ms and save them in an excel or MATLAB format.

- 1. Measure conduction NTN Tx power corresponding to SAR regulation.
- 2. Set NTN power level with some margin. Then, start the test.
- 3. Execute time-varying test scenarios. Record NTN power using sub-6GHz power meter equipment.
- 4. Plot the recorded results over measurement time. Evaluate the results for validation.

Note that Plimit is different according to the OEM, so it is necessary to set the Plimit suitable for each terminal.

TEL: 886-3-327-3456 Page: 20 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 8.3 Measured Plimit and Pmax

The measured *Plimit* for all the selected radio configurations are listed in Table 7.2.1. *Pmax* was also measured for radio configurations selected for testing time-varying Tx power transmission scenario in order to generate test sequences following the test procedures.

Report No.: FA4N0917C

The instantaneous maximum power for WWAN antennas is min {Pmax, Plimit+6 dB} during TAS power transmission behavior.

Table 7.2.1 Measured *Plimit* and *Pmax* of selected radio configurations

item	Test Scenario	Antenna	Power Index	Test band	Mode	Pmax Setting (dBm)	measured Pmax (dBm)	Plimit Setting (dBm)	Measured Plimit (dBm)	Total Uncertainty (dB)
1		TX1_Ant 0	4	WCDMA B2	RMC 12.2Kbps	23.6	22.95	16.8	16.87	0.7
2		TX0_Ant 2	5	WCDMA B4	RMC 12.2Kbps	24	23.48	21.5	20.93	1.2
3	Time varying Tx power case 1	TX0_Ant 1	3	LTE B25/B2	QPSK_20M/50/0	24	21.01	15.1	15.02	1
4	Time varying 1x power case 1	TX1_Ant 5	5	LTE B66/4	QPSK_20M/50/0	23.7	23.61	22.7	22.58	0.9
5		TX0_Ant 2	5	n30 (SA Mode)	BPSK_10M/1/1	21.6	21.46	20.3	20.12	0.9
6		TX0_Ant 1	3	n41/n38 pc3 (SA Mode)	BPSK_100M/1/1	24.1	18.75	13.1	12.78	0.9
7		TX1_Ant 0	4	WCDMA B2	RMC 12.2Kbps	23.6	22.95	16.8	16.87	0.7
8		TX0_Ant 2	5	WCDMA B4	RMC 12.2Kbps	24	23.48	21.5	20.93	1.2
9	Time varying Tx power case 2	TX0_Ant 1	3	LTE B25/B2	QPSK_20M/50/0	24	21.01	15.1	15.02	1
10	Time varying 1x power case 2	TX1_Ant 5	5	LTE B66/4	QPSK_20M/50/0	23.7	23.61	22.7	22.58	0.9
11		TX0_Ant 2	5	n30 (SA Mode)	BPSK_10M/1/1	21.6	21.46	20.3	20.12	0.9
12		TX0_Ant 1	3	n41/n38 pc3 (SA Mode)	BPSK_100M/1/1	24.1	18.75	13.1	12.78	0.9
13	Change in operating state	TX0_Ant 1	5	n41/n38 pc3 (SA Mode)	BPSK_100M/1/1	24.1	23.73	19.9	19.67	0.9
13	Change in operating state	TX0_Ant 1	3	n41/n38 pc3 (SA Mode)	BPSK_100M/1/1	24.1	18.75	13.1	12.78	0.9
14	Call_Disconnect_Reestablishment	TX0_Ant 1	3	LTE B25/B2	QPSK_20M/50/0	24	21.01	15.1	15.02	1
15	NSA FR1 Dominant Power Switching	TX0_Ant 6	4	LTE B48	QPSK_20M/1/0	17.8	17.67	19.2	17.67	1.1
15	NSA_FRI_Dominant_Fower_Switching	TX1_Ant 0	4	n25/n2 (NSA Mode)	BPSK_40M/1/1	23.6	23.27	17.2	17.35	0.5
16	NR_TO_LTE_IRAT_HO	TX1_Ant 0	4	n7 (SA Mode)	BPSK_50M/1/1	23.8	23.11	17	17.04	0.9
16	NR_TO_LTE_IRAT_HO	_LTE_IRAT_HO TX0_Ant 6 4		LTE B48	QPSK_20M/1/0	17.8	17.67	19.2	17.67	1.1
17	UL CA	TX1 Ant 0	4	LTE B7_PCC	QPSK_20M/1/0	23.8	23.51	18	17.79	0.8
17	OL CA	I A I _AIIL U	4	LTE B7_PCC+SCC	QPSK_20M/1/99	23.8	22.39	10	16.73	0.0
18	NTN_Time_Varying_Startup_sequence	Ant 1	5	NTN B23	BPSK/15k/1/0	21.7	22.6	21.1	20.6	1

Note that the EUT has multiple power indexes to manage the output power for different conditions corresponding to RF exposure conditions in above table, detailed power index trigger conditions are illustrated in the operational description, and 1g and 10g SAR design target are shown in the part 0 report.

TC#	Test Scenario	Antenna	Polarization	Power Index	Test band	Configuration	Pmax Stting (dBm)	measured Pmax (dBm)	Plimit Setting (dBm)	Measured Plimit (dBm)	Measured EIRP (dBm)	Device Uncertainty (dB)
1	Time-varying Tx	0	-	4	LTE B2	QPSK_20M/1/0	23.6	24.2	16.8	17	-	1
ļ	power transmission	-	H+V	-	n258	QPSK_100M/1/0	-	-	7.94	-	10.35	2.3
2	SAR exposure switch	0	-	4	LTE B2	QPSK_20M/1/0	23.6	24.2	16.8	17	-	1
		-	H+V	-	n258	QPSK_100M/1/0	-	-	7.94	-	10.35	2.3
		-	H+V	-	n258	QPSK_100M/1/0	-	-	7.94	-	10.35	2.3
3	Change of beam	-	H+V	-	n258	QPSK_100M/1/0	-	-	7.94	-	10.2	2.3
		-	H+V	-	n258	QPSK_100M/1/0	-	-	7.94	-	10.35	2.3
4	NDDO	0	-	4	FR1 n25	BPSK_40M/1/1	23.6	24.5	17.2	17.3	-	1
4	NRDC	-	H+V	-	n258	QPSK_100M/1/0	-	-	7.94	-	10.35	2.3

Plimit setting which can be referenced from Part 0 report is for single polarization, so the dual-pol EIRP target is equivalent to Plimit plus 3dB.

TEL: 886-3-327-3456 Page: 21 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



# FCC RF Exposure Report

# 8.4 Sub-6 summary test results

item	Test Scenario	Antenna	Power Index	Test band	Mode	Total Uncertainty (dB)	1g SAR design target (W/kg)	1g Time average SAR (W/kg)	Deviation (dB)
1		TX1_Ant 0	4	WCDMA B2	RMC 12.2Kbps	0.7	0.667	0.635	-0.21
2		TX0_Ant 2	5	WCDMA B4	RMC 12.2Kbps	1.2	0.347	0.309	-0.50
3	Time varying Tx power case 1	TX0_Ant 1	3	LTE B25/B2	QPSK_20M/50/0	1	0.63	0.578	-0.37
4	Time varying 1x power case 1	TX1_Ant 5	5	LTE B66/4	QPSK_20M/50/0	0.9	0.563	0.518	-0.36
5		TX0_Ant 2	5	n30 (SA Mode)	BPSK_10M/1/1	0.9	0.369	0.339	-0.37
6		TX0_Ant 1	3	n41/n38 pc3 (SA Mode)	BPSK_100M/1/1	0.9	0.649	0.642	-0.05
7		TX1_Ant 0	4	WCDMA B2	RMC 12.2Kbps	0.7	0.667	0.627	-0.27
8		TX0_Ant 2	5	WCDMA B4	RMC 12.2Kbps	1.2	0.347	0.281	-0.92
9	Time vening Typewer age 2	TX0_Ant 1	3	LTE B25/B2	QPSK_20M/50/0	1	0.63	0.58	-0.36
10	Time varying Tx power case 2	TX1_Ant 5	5	LTE B66/4	QPSK_20M/50/0	0.9	0.563	0.477	-0.72
11		TX0_Ant 2	5	n30 (SA Mode)	BPSK_10M/1/1	0.9	0.369	0.328	-0.51
12		TX0_Ant 1	3	n41/n38 pc3 (SA Mode)	BPSK_100M/1/1	0.9	0.649	0.623	-0.18
10	Change in apprehing state	TX0_Ant 1	5	n41/n38 pc3 (SA Mode)	BPSK_100M/1/1	0.9	0.678	0.650	0.40
13	Change in operating state	TX0_Ant 1	3	n41/n38 pc3 (SA Mode)	BPSK_100M/1/1	0.9	0.649	0.658	-0.13
14	Call_Disconnect_Reestablishment	TX0_Ant 1	3	LTE B25/B2	QPSK_20M/50/0	1	0.63	0.573	-0.41
15	NSA FR1 Dominant Power Switching	TX0_Ant 6	4	LTE B48	QPSK_20M/1/0	1.1	0.34	0.542	-0.47
15	NSA_FRI_Dominant_Fower_Switching	TX1_Ant 0	4	n25/n2 (NSA Mode)	BPSK_40M/1/1	0.5	0.604	0.542	-0.47
16	NR TO LTE IRAT HO	TX1_Ant 0	4	n7 (SA Mode)	BPSK_50M/1/1	0.9	0.534	0.616	0.62
10	NR_TO_LTE_IRAT_HO	TX0_Ant 6	4	LTE B48	QPSK_20M/1/0	1.1	0.34	0.010	0.02
17	UL CA	TX1 Ant 0	4	LTE B7_PCC	QPSK_20M/1/0	0.8	0.609	0.561	-0.36
17	UL CA	TAT_Ant 0	4	LTE B7_PCC+SCC	QPSK_20M/1/99	0.8	0.609	0.001	-0.36
18	NTN_Time_Varying_Startup_sequence	Ant 1	5	NTN B23	BPSK/15k/1/0	1	0.79	0.789	-0.01

Report No.: FA4N0917C

item	Test Scenario	Antenna	Power Index	Test band	Configuration	1g SAR design target (W/kg)	PD design target (Mw/cm^2)	TER	PD design target + total uncertainty	Uncertainty
1	Time-varying Tx power	0	4	LTE B2	QPSK_20M/1/0	0.75	-	0.614	0.75	2.3
2	transmission 1	-	1	n258	QPSK_100M/1/0	-	4.42			
3	045	0	4	LTE B2	QPSK_20M/1/0	0.75	-	0.575	0.75	2.3
4	SAR exposure switch	-	-	n258	QPSK_100M/1/0	-	4.42	0.575		
5	0, 4,	0	4	LTE B2	QPSK_20M/1/0	0.75	-	0.070	0.75	0.0
6	Change of beam	-	-	n258	QPSK_100M/1/0	-	4.42	0.679	0.75	2.3
7	NRDC	0	4	FR1 n25	BPSK_40M/1/1	0.75	-	0.502	0.75	2.3
8		-	-	n258	QPSK_100M/1/0	-	4.42	0.302	0.75	2.3

TEL: 886-3-327-3456 Page: 22 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 8.5 <u>Time-varying Tx power measurement results</u>

Following the test procedure in Section 3, the conducted Tx power measurement results for all selected test cases are listed in this section. In all conducted Tx power plots, the blue line shows the measured instantaneous power using the power meter, the red line shows the time-averaged Tx power and yellow line shows the Plimit value corresponding to design target. In all SAR plots, the dotted blue line shows the time-averaged 1gSAR while the red line shows the corresponding FCC limit of 1.6W/Kg. Time-varying Tx power measurements were conducted for TC#1 - 12 in Table 7.2.1 by generating the test sequence A or B given in Appendix.

Report No.: FA4N0917C

### 7.3.1 TC01: WCDMA B2\_Time\_Varying\_Tx\_Power\_Case\_1

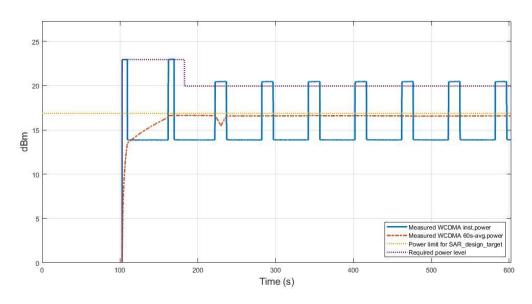


Figure 7.3-1 Time average conducted power

Figure 7.3-1 shows the conducted Tx power plot with calculated time-averaged power based on the measured instantaneous Tx power with 1gSAR FCC Limit value. As shown in Figure 7.3-1, it is confirmed for time- average Tx power that the FCC limit was not exceeded, and that the averaged Tx power is smaller than the target power, and it will saturate to target power with little margin. Figure 7.3-2 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 23 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



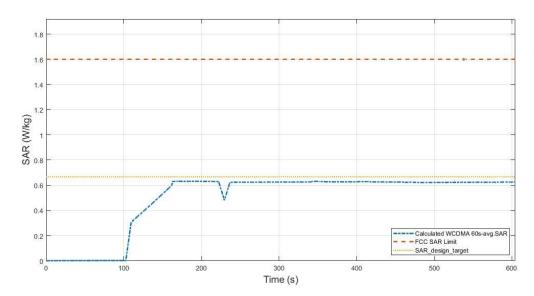


Figure 7.3-2 Total time-averaged SAR

I igate 7:0 2 Total time averagea OAIX			
FCC 1gSAR limit	1.6 W/kg		
Max time average 1gSAR (blue curve)	0.635 W/kg		
Device uncertainty	0.7 dB		

TEL: 886-3-327-3456 Page: 24 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# Report No.: FA4N0917C

# 7.3.2 TC02: WCDMA B4\_Time\_Varying\_Tx\_Power\_Case\_1

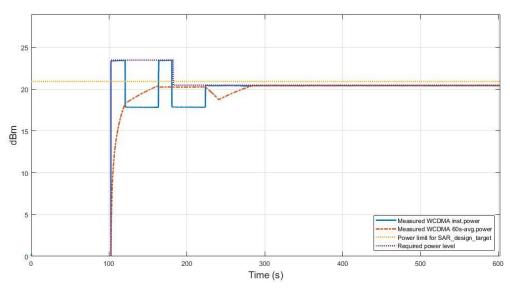


Figure 7.3-3 Time-average conducted power

Figure 7.3-3 shows the instantaneous and time-averaged Tx power for this test. As shown in Figure 7.3-3, it is confirmed for time-average Tx power that the FCC limit was not exceeded, and that the averaged Tx power is lower than the value of Plimit. Figure 7.3-4 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 25 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

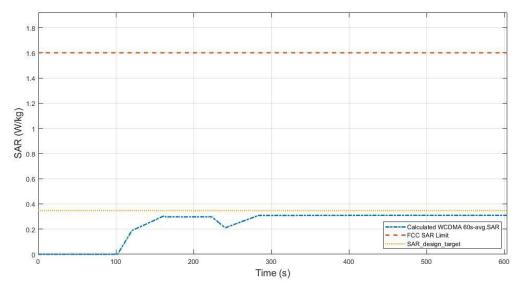
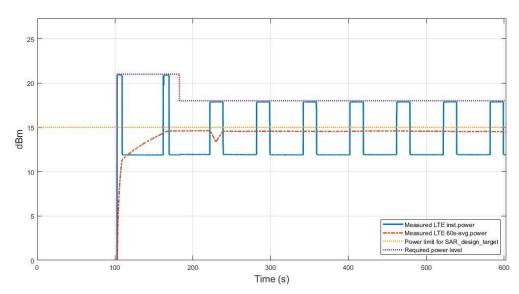


Figure 7.3-4 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.309 W/kg
Device uncertainty	1.2 dB

TEL: 886-3-327-3456 Page: 26 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 7.3.3 TC03: LTE Band 25/2\_Time\_Varying\_Tx\_Power\_Case\_1



Report No.: FA4N0917C

Figure 7.3-5 Time-average conducted power

Figure 7.3-5 shows the instantaneous and time-averaged Tx power for this test. As shown in Figure 7.3-5, it is confirmed for time-average Tx power that the FCC limit was not exceeded, and that the averaged Tx power is lower than the value of Plimit. Figure 7.3-6 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 27 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

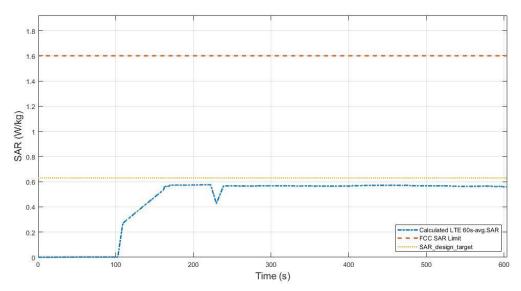
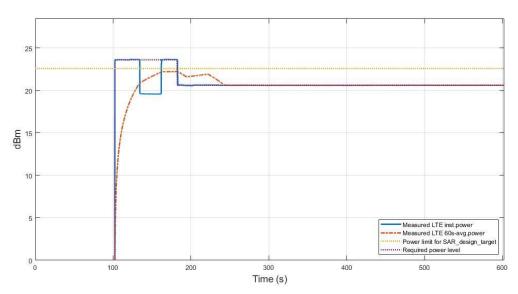


Figure 7.3-6 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.578 W/kg
Device uncertainty	1 dB

TEL: 886-3-327-3456 Page: 28 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 7.3.4 TC04: LTE Band 66/4\_Time\_Varying\_Tx\_Power\_Case\_1



Report No.: FA4N0917C

Figure 7.3-7 Time-average conducted power

Figure 7.3-7 shows the instantaneous and time-averaged Tx power for this test. As shown in Figure 7.3-7, it is confirmed for time-average Tx power that the FCC limit was not exceeded, and that the averaged Tx power is lower than the value of Plimit. Figure 7.3-8 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 29 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



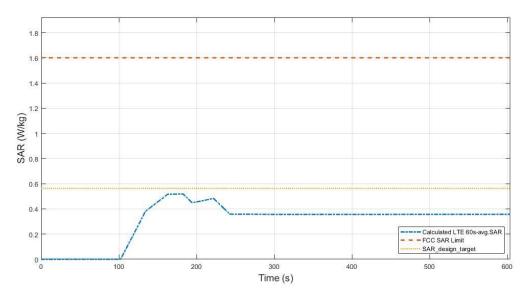


Figure 7.3-8 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.518 W/kg
Device uncertainty	0.9 dB

TEL: 886-3-327-3456 Page: 30 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

Report No.: FA4N0917C

# 7.3.5 TC05: FR1 n30 SA mode\_Time\_Varying\_Tx\_Power\_Case\_1

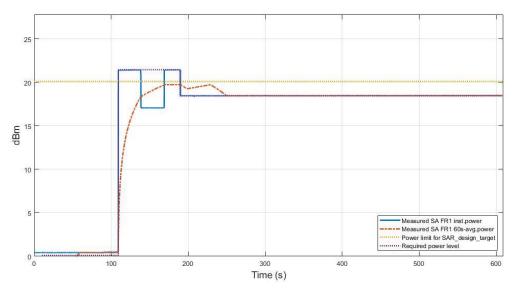


Figure 7.3-9 Conducted Tx power

Figure 7.3-9 shows the instantaneous and time-averaged Tx power for this test. As shown in Figure 7.3-9, it is confirmed for time-average Tx power that the FCC limit was not exceeded, and that the averaged Tx power is lower than the value of Plimit. Figure 7.3-10 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 31 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



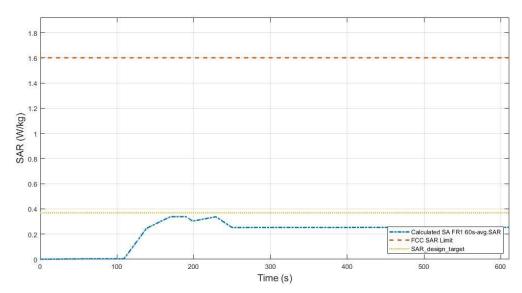


Figure 7.3-10 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.339 W/kg
Device uncertainty	0.9 dB

TEL: 886-3-327-3456 Page: 32 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

Report No.: FA4N0917C

# 7.3.6 TC06: FR1 n41/38 SA mode\_Time\_Varying\_Tx\_Power\_Case\_1

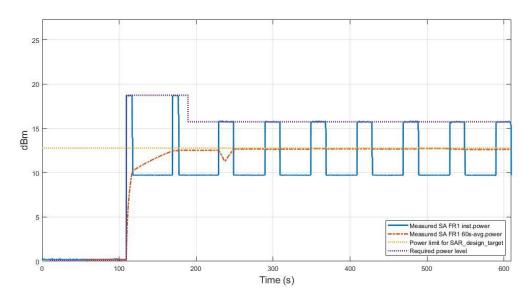


Figure 7.3-11 Conducted Tx power

Figure 7.3-11 shows the instantaneous and time-averaged Tx power for this test. As shown in Figure 7.3-11, it is confirmed for time-average Tx power that the FCC limit was not exceeded, and that the averaged Tx power is lower than the value of Plimit. Figure 7.3-12 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 33 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



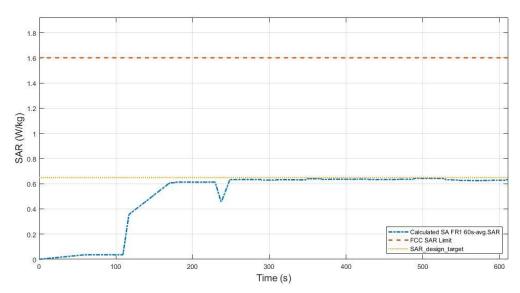


Figure 7.3-12 Total time-averaged SAR in F\_TC04

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.642 W/kg
Device uncertainty	0.9 dB

TEL: 886-3-327-3456 Page: 34 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

Report No.: FA4N0917C

# 7.3.7 TC07: WCDMA B2\_Time\_Varying\_Tx\_Power\_Case\_2

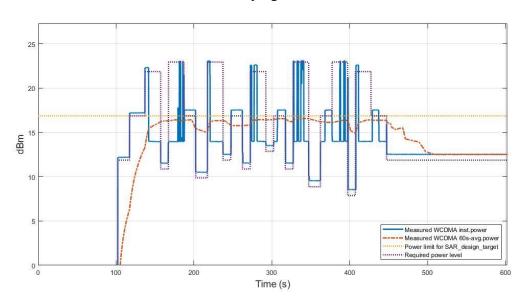


Figure 7.3-13 Conducted Tx power

Figure 7.3-13 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 7.3-14 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 35 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

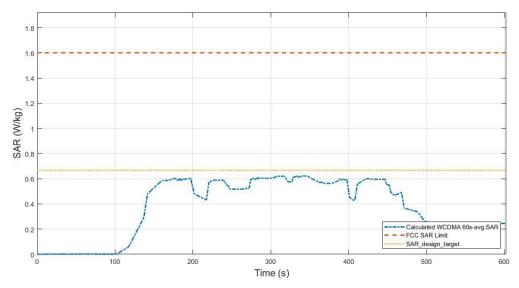


Figure 7.3-14 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.627 W/kg
Device uncertainty	0.7 dB

TEL: 886-3-327-3456 Page: 36 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 7.3.8 TC08: WCDMA B4\_Time\_Varying\_Tx\_Power\_Case\_2

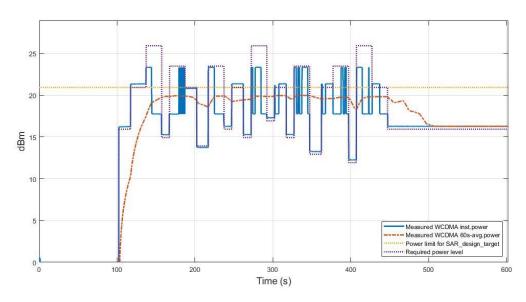


Figure 7.3-15 Conducted Tx power

Figure 7.3-15 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 7.3-16 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 37 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



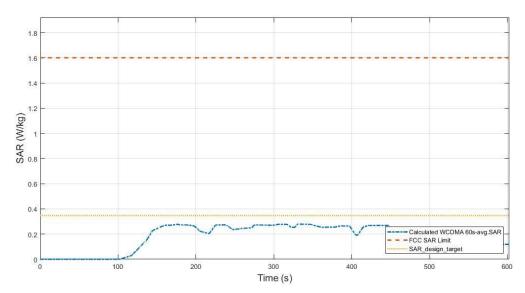


Figure 7.3-16 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.281 W/kg
Device uncertainty	1.2 dB

TEL: 886-3-327-3456 Page: 38 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 7.3.9 TC09: LTE Band 25/2\_Time\_Varying\_Tx\_Power\_Case\_2

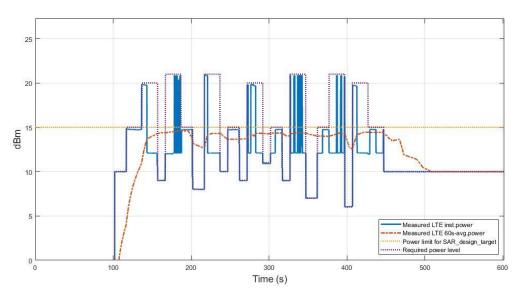


Figure 7.3-17 Conducted Tx power

Figure 7.3-17 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 7.3-18 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 39 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

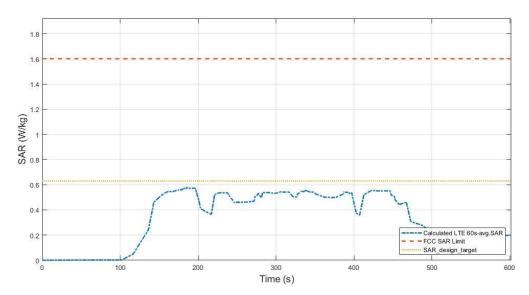


Figure 7.3-18 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.58 W/kg
Device uncertainty	1 dB

TEL: 886-3-327-3456 Page: 40 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 7.3.10 TC10: LTE Band 66/4\_Time\_Varying\_Tx\_Power\_Case\_2

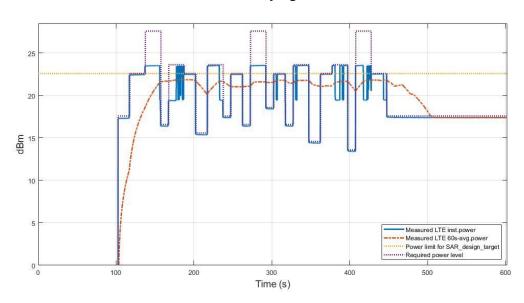


Figure 7.3-19 Conducted Tx power

Figure 7.3-19 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 7.3-20 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 41 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

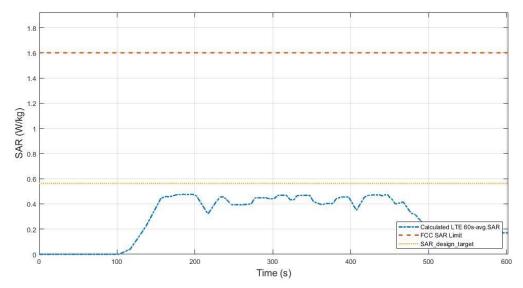


Figure 7.3-20 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.477 W/kg
Device uncertainty	0.9 dB

TEL: 886-3-327-3456 Page: 42 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 7.3.11 TC11: FR1 n30 SA mode \_Time\_Varying\_Tx\_Power\_Case\_2

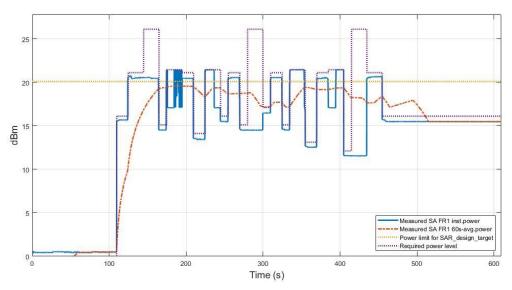


Figure 7.3-21 Conducted Tx power

Figure 7.3-21 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 7.3-22 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 43 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

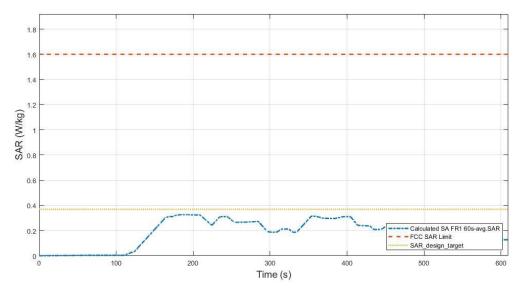


Figure 7.3-22 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.328 W/kg
Device uncertainty	0.9 dB

TEL: 886-3-327-3456 Page: 44 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 7.3.12 TC12: FR1 n41/n38 SA mode\_Time\_Varying\_Tx\_Power\_Case\_2

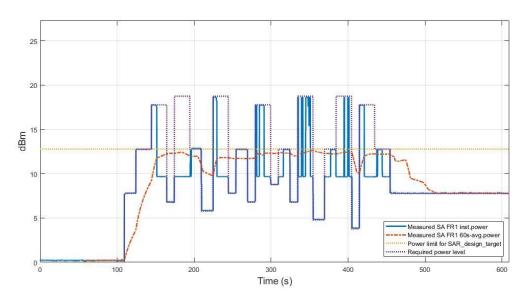


Figure 7.3-23 Conducted Tx power

Figure 7.3-23 shows the instantaneous and time-averaged Tx power with test sequence B. Figure 7.3-24 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 45 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



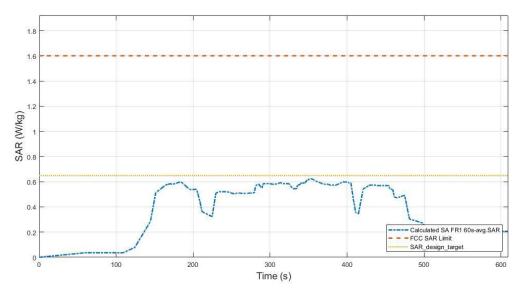


Figure 7.3-24 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.623 W/kg
Device uncertainty	0.9 dB

Page: 46 of 70 TEL: 886-3-327-3456 FAX: 886-3-328-4978 Issued Date : Apr. 21, 2025

# 8.6 Change in Power Index

The test results in this section are obtained following the procedure in Section 3. The test cases correspond to TC#13 in Table 7.2.1.

Report No.: FA4N0917C

#### 7.4.1 TC13: SA\_FR1 n41/n38\_RF\_SAR\_Index\_Change

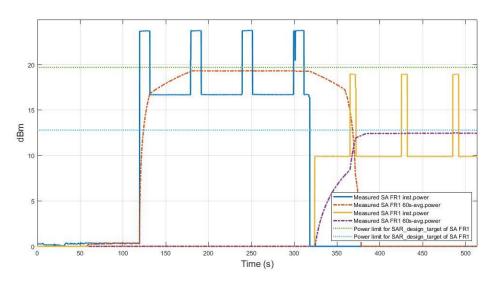


Figure 7.4-1 Conducted Tx power for SAR states change

Figure 7.4-1 shows the instantaneous and time-averaged conducted Tx power for the duration of the test. Figure 7.4-2 shows the time-averaged 1gSAR value for each of power index 5 and power index 3 value, as well as the total SAR value.

TEL: 886-3-327-3456 Page: 47 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



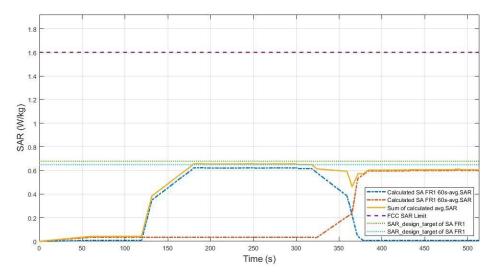


Figure 7.4-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max sum of calculated average SARs (yellow curve)	0.658 W/kg
Device uncertainty	0.9 dB

TEL: 886-3-327-3456 Page: 48 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 8.7 Change in call test results

The test results in this section are obtained following the procedure in Section 3. The test case corresponds to TC#14 in Table 7.2.1.

Report No.: FA4N0917C

#### 7.6.1 TC14: LTE Band 25/2\_Call\_Disconnect\_Reestablishment

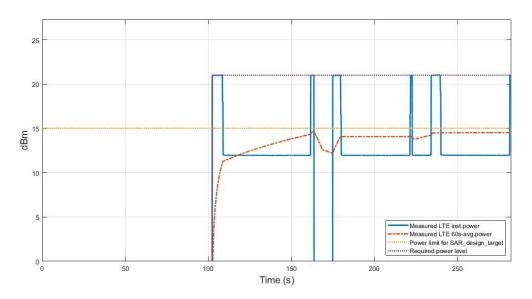


Figure 7.6-1 Conducted Tx power in Call\_Disconnect\_Reestablishment

Figure 7.6-1 shows the instantaneous and time-averaged Tx power for this test. The call disconnected around 160s and resumed after 10s. It is confirmed for time-average Tx power that the FCC limit was not exceeded, and that the averaged Tx power is lower than the value of Plimit. Figure 7.6-2 shows the plot of calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg. Looking at the results, it can be seen that even if transmission is stopped due to a call drop, the SAR value measured for a period of time window is stored in the window section and is continuously checked.

TEL: 886-3-327-3456 Page: 49 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



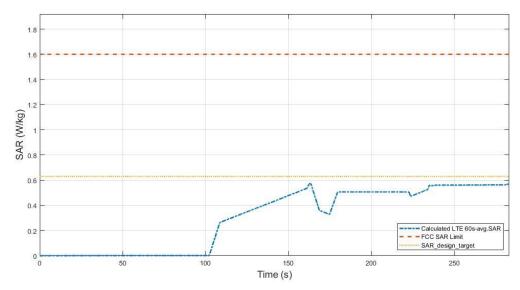


Figure 7.6-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max time average 1gSAR (blue curve)	0.573 W/kg
Device uncertainty	1 dB

TEL: 886-3-327-3456 Page: 50 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 8.8 Switch in SAR exposure test results

The test results in this section are obtained following the procedure in Section 3. The test cases correspond to TC#15 in Table 7.2.1.

Report No.: FA4N0917C

#### 8.8.1 TC15: NSA\_FR1\_Dominant\_Power\_Switching (ENDC LTE Band 48\_n25/n2)

In this LTE Band 48+FR1 n25/n2 NSA scenario, we first establish LTE and NR call. In the first part of test, LTE is sent to lowest transmit power using "ALL DOWN" power control commands from call box while NR is sent to maximum power using "ALL UP" power control commands from call box. This would correspond to FR1 dominant SAR scenario and lasts about 110s. In the second part of test, LTE is sent "ALL UP" commands and transmissions are continued, resulting in LTE+FR1 SAR scenario lasting another 110s. In the third part of test, NR is sent "ALL DOWN" power control commands so that it becomes an FR1 dominant SAR scenario for 110s. Finally, both LTE and NR connections are released.

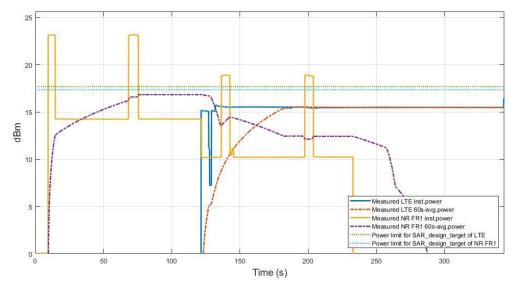


Figure 7.7-1 Time average SAR of LTE B48 and FR1 n25/n2 in EN-DC case

Figure 7.8-1 shows the instantaneous and time-averaged Tx power for both LTE band B48 and NR FR1 band n25/n2 versus time. When both LTE and FR1 operate, the SAR value was the highest instantaneously, but it can be seen that sum of average power in LTE and FR1 decreases again as soon as it is turned off. Figure 7.7-2 shows the computed time-averaged SAR value for LTE and FR1 as well as the sum. It was confirmed that algorithm operated under the SAR design target + total uncertainty, while also being under the FCC limit of 1.6W/Kg at all times. After the operation of FR1 is turned off, it can also be seen that the average power of LTE increases.

TEL: 886-3-327-3456 Page: 51 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025



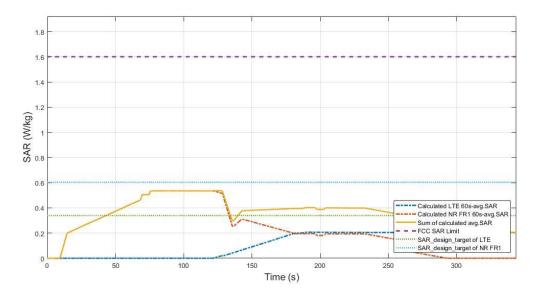


Figure 7.7-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max sum of calculated average SARs (yellow curve)	0.542 W/kg
Device uncertainty	1.1 dB

TEL: 886-3-327-3456 Page: 52 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 8.9 Re-selection in call test results

The test results in this section are obtained following the procedure in Section 3. The test cases correspond to TC#16 in Table 7.2.1.

Report No.: FA4N0917C

#### 7.8.1 TC16: FR1 n7 to LTE Band 48 IRAT Re-selection

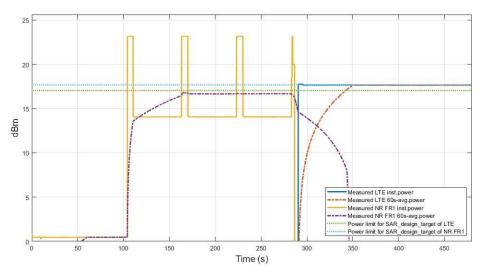


Figure 7.8-1 Conducted Tx power for SAR IRAT re-selection

Figure 7.8-1 shows the instantaneous and time-averaged conducted Tx power for both LTE Band 48 and NR FR1 n7 for the duration of the test. Around time stamp of ~280s, a RAT re-selection from LTE Band 48 to NR FR1 n7 was executed, resulting in reduction of time-averaged power of Band 48 and simultaneous increase in time-averaged power of n7. Figure 7.8-2 shows the time-averaged 1gSAR value for each of LTE Band 48 and NR FR1 n7, as well as the total SAR value.

TEL: 886-3-327-3456 Page: 53 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

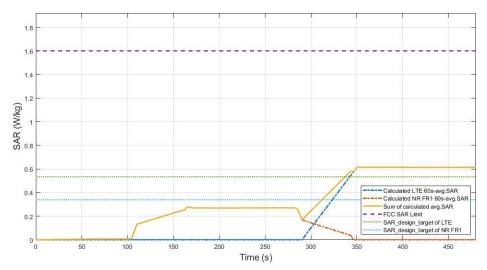


Figure 7.8-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max sum of calculated average SARs (yellow curve)	0.616 W/kg
Device uncertainty	1.1 dB

TEL: 886-3-327-3456 Page: 54 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 8.10 LTE Uplink CA

The test results in this section are obtained following the procedure in Section 3. The test cases correspond to TC#17 in Table 7.2.1.

Report No.: FA4N0917C

#### 7.9.1TC17: LTE\_UL\_CA (LTE Band 7)

Figure 7.10-1 shows the conducted Tx power plot with calculated time-averaged power based on the measured instantaneous Tx power with 1gSAR FCC Limit value. In this test, SAR\_design\_target would be 0.7W/kg at 18dBm. The setting value and measured values are described in Table 7.2.1. An MPR of 2dB is configured within this band so with 100% duty cycle the maximum power should be reaching 23.8dBm.

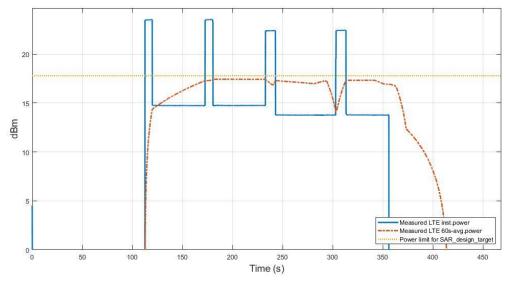


Figure 7.9-1 Conducted transmitted power of LTE Band 7 in UL CA

Next after 120s, an intra-band CA is configured (CA\_7C) where a new CC is added and the transmission is continued for another 120s. As shown in Figure 7.9-1, the total power of the two CC is kept almost the same as in the single CC transmission. Average power in Figure 7.9-1 assures the compliance of the average power of the transmitted signal which is below 18dBm and consequently the average SAR in Figure 7.9-2 is below 1W/kg which is below the FCC limit of 1.6W/kg

TEL: 886-3-327-3456 Page: 55 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

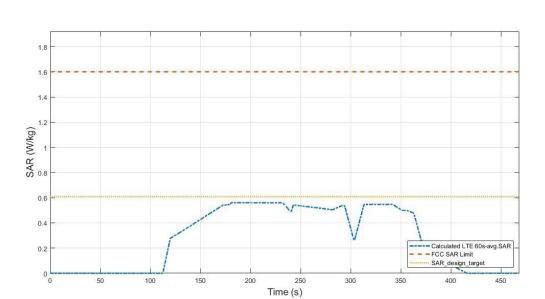


Figure 7.9-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max sum of calculated average SARs (blue curve)	0.561 W/kg
Device uncertainty	0.8 dB

TEL: 886-3-327-3456 Page : 56 of 70 FAX: 886-3-328-4978 Issued Date : Apr. 21, 2025

## 8.11 NTN with time-varying startup test sequence

The test results in this section are obtained following the procedure in Section 3. The test cases correspond to TC#18 in Table 7.2.1.

Report No.: FA4N0917C

#### 7.11.1 TC18: NTN\_Time\_Varying\_Startup\_sequence

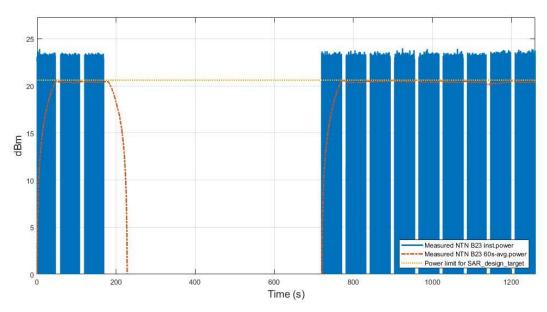


Figure 7.11-1 Conducted Tx power for NTN\_Time\_Varying\_Startup\_sequence

Figure 7.11-1 shows the conducted Tx power plot with calculated time-averaged power based on the measured instantaneous Tx power with 1gSAR FCC Limit value. As shown in Figure 7.11-1, it is confirmed for 60s time average Tx power that the FCC limit was not exceeded, and that the averaged Tx power is smaller than the target power, and it will saturate to target power with little margin. Figure 7.11-2 shows the plot of calculated 60s time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/Kg.

TEL: 886-3-327-3456 Page: 57 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

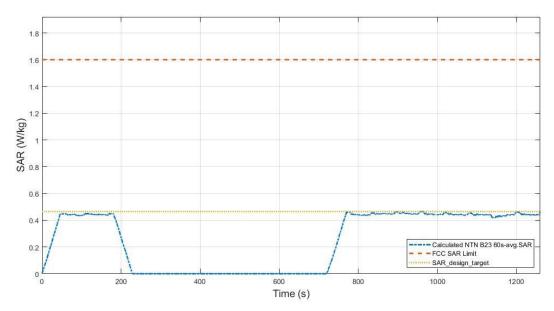


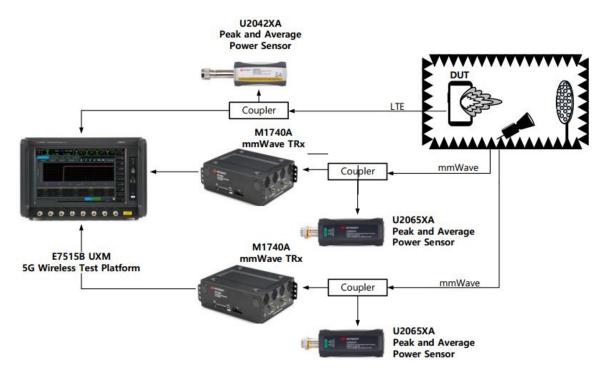
Figure 7.11-2 Total time-averaged SAR

FCC 1gSAR limit	1.6 W/kg
Max sum of calculated average SARs (yellow curve)	0.789 W/kg
Device uncertainty	1 dB

TEL: 886-3-327-3456 Page: 58 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 9. FR2 Radiated power Test Results for TAS validation

## 9.1 <u>Measurement setup</u>



Report No.: FA4N0917C

Figure 8.1-1 Test set-up for mmWave

In mmWave technology, we are not able to measure conducted power at antenna, so only radiated power in the form of EIRP (equivalent isotropically radiated power) will be measured in an anechoic chamber. The test setup is illustrated in Figure 8.1-1. For NSA (non-standalone) operation, legacy LTE technology will also be active and this connection can be done via a connected port of the DUT. A power sensor can be coupled to the LTE transmission. There is a concept of two orthogonal polarization measurements (horizontal and vertical) in mmWave, and so two additional power sensors are needed to measure both. There are remote radio-heads required to performance up/down-conversion of the mmWave signal from/to the call box. The Keysight UXM call box is capable of establishing both LTE and FR2 connections. The coupled power sensors in mmWave uplink will be logged along with the LTE power simultaneously for post-processing on the PC. The LTE power is then mapped to SAR, while the mmWave power readings will be mapped to PD using the characterization data. The direction of DUT is set to see the worst case corresponding to module and beam showing the highest PD in characterization as described in Section 5.3. By validation in this conservative worst PD case, all other cases can be regarded as to be validated as well.

In summary, PD test has to be executed as following procedure (more detailed procedure in Section 5.3).

- Measure conduction sub 6GHz Tx power corresponds to SAR regulation and measure Tx EIRP corresponds to PD regulation. For mmWave, E-field PD measurement TE is used instead of EIRP measurements.
- 2. Set sub 6GHz and mmWave power level with some margin. And start the test.
- 3. Execute time-varying test scenarios. And record sub 6GHz power using sub 6GHz power meter equipment and EIRP value using mmWave power meter.
- 4. Plot the recorded results over measurement time. And evaluate the results for validation.

TEL: 886-3-327-3456 Page: 59 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 9.2 <u>Time-varying Tx power measurement results</u>

The results in this section were obtained following the procedure in Section 7.2 and corresponds to the test case I\_TC01 in Table 7.2.1.

Report No.: FA4N0917C

#### 8.2.1 F TC01: mmWave Max Tx Power

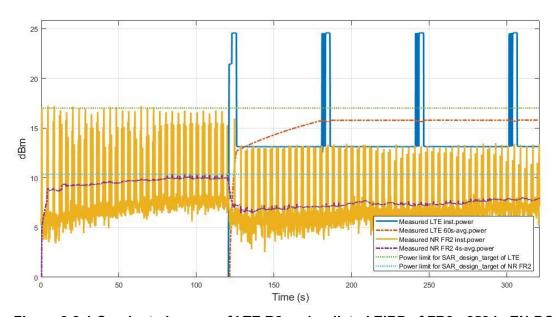


Figure 8.2-1 Conducted power of LTE B2 and radiated EIRP of FR2 n258 in EN-DC

Figure 8.2-1 shows the instantaneous and time-averaged conducted power for LTE and radiated power for NR FR2. In this test, we assumed that Plimit value for LTE is 17dBm when SAR\_design target is 0.75W/Kg, and the Plimit value of FR2 is 7.94 dBm when PD\_design\_target is 4.42W/m2. When LTE is operated, FR2 power would be decreased to maintain TER value. After the average power of LTE is saturated as target power, the average power of FR2 is not decreased any more. As a result, although LTE is turned on, the TER value doesn't increase or decrease. Figure 8.2-2 shows the computed normalized and time-averaged SAR and PD values for LTE and NR FR2, respectively, as well as their sum which is the TER value. We can see that the TER is always under the FCC compliance limit of 1, thus validating the TAS feature in this test case.

TEL: 886-3-327-3456 Page: 60 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

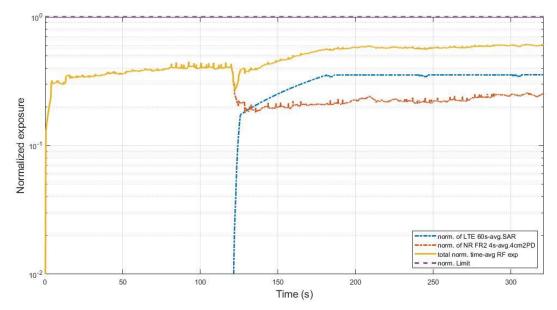


Figure 8.2-2 Total normalized time-average RF exposure in F\_TC01

FCC requirement for total RF exposure (normalized)	1.0
Max total normalized time-averaged RF exposure (yellow curve)	0.614
Validated	

TEL: 886-3-327-3456 Page: 61 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 9.3 SAR vs. PD exposure switch

The results in this section were obtained following the procedure in Section 7.2 and corresponds to the test case F\_TC02 in Table 7.2.1.

Report No.: FA4N0917C

#### 8.3.1 F\_TC02: mmWave\_Dominant\_Power\_Switching

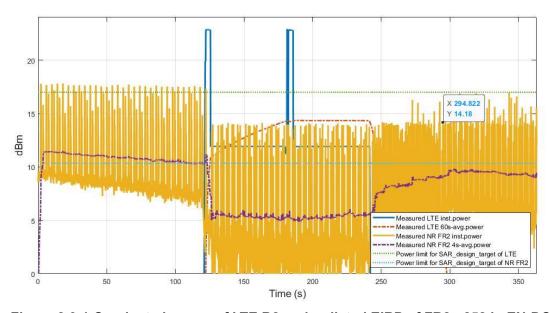


Figure 8.3-1 Conducted power of LTE B2 and radiated EIRP of FR2 n258 in EN-DC

Figure 8.3-1 shows the instantaneous and time-averaged conducted power for LTE and radiated power for NR FR2. In this test, we assumed that Plimit value for LTE is 17dBm when SAR\_design target is 0.75W/Kg, and the Plimit value of FR2 is 7.94 Bm when PD\_design\_target is 4.42 W/m2. When LTE is operated, FR2 power would be decreased to maintain TER value. After the average power of LTE is saturated as target power, the average power of FR2 is not decreased any more. After LTE is turned off, the average power of FR2 is increased to restore the original target power. As a result, whether LTE is turned on or not, the TER value dramatically doesn't increase or decrease. Figure 8.3-2 shows the computed normalized and time-averaged SAR and PD values for LTE and NR FR2, respectively, as well as their sum which is the TER value. We can see that the TER is always under the FCC compliance limit of 1, thus validating the TAS feature in this test case.

TEL: 886-3-327-3456 Page: 62 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

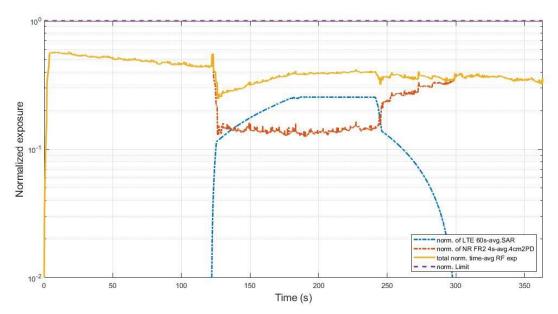


Figure 8.3-2 Total normalized time-average RF exposure in F\_TC02

FCC requirement for total RF exposure (normalized)	1.0			
Max total normalized time-averaged RF exposure (yellow curve)	0.575			
Validated				

TEL: 886-3-327-3456 Page: 63 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 9.4 FR2 beam change

The results in this section were obtained following the procedure in Section 7.2 and corresponds to the test case F\_TC03 in Table 7.2.1.

Report No.: FA4N0917C

#### 8.4.1 F\_TC03: mmWave\_Module\_Beam\_Change

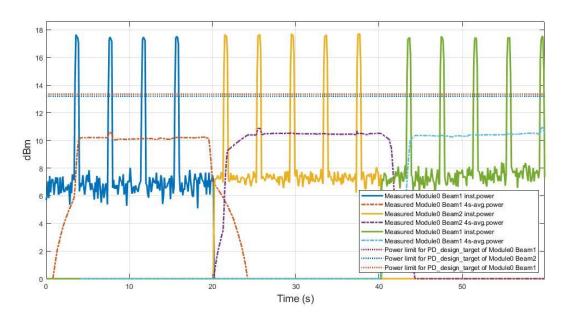


Figure 8.4-1 Measured radiated EIRP of FR2 n258 in mmWave Module beam change case F\_TC03

Figure 8.4-1 shows the instantaneous and time-averaged radiated power for NR FR2. We don't show the LTE transmit power, since it would be at the lowest level and doesn't meaningfully contribute to the TER. In this test, we assumed that the Plimit value of FR2 is 7.94dBm when PD\_design\_target is 4.42W/m2. Figure 8.4-2 shows the computed time-averaged PD for each selected module/beam setting as well as the total sum. When beam or module of FR2 would be changed, the sum of each beam/module is not higher than the target power limit. As a result, whether beam/module is changed or not, the TER value dramatically doesn't increase.

TEL: 886-3-327-3456 Page: 64 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

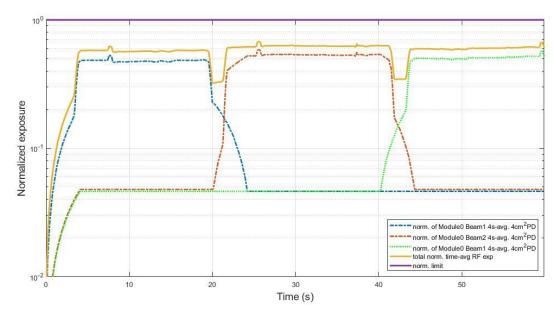


Figure 8.4-2 Total normalized time-average RF exposure

FCC requirement for total RF exposure (normalized)	1.0			
Max total normalized time-averaged RF exposure (yellow curve)	0.679			
Validated				

TEL: 886-3-327-3456 Page: 65 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

## 9.5 NR Dual Connectivity

The results in this section were obtained following the procedure in Section 7.2 and corresponds to the test case F\_TC04 in Table 7.2.1.

Report No.: FA4N0917C

#### 8.5.1 F\_TC04: mm\_Wave\_NR\_DC

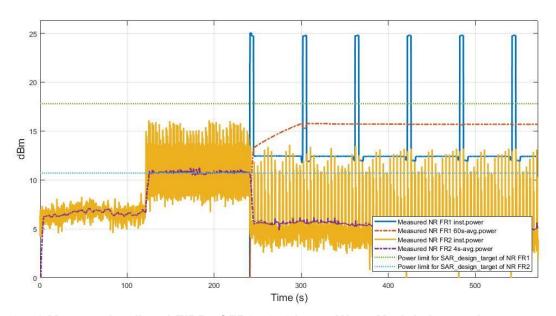


Figure 8.5-1 Measured radiated EIRP of FR2 n258 in mmWave Module beam change case TC04

Figure 8.5-1 shows the instantaneous and time-averaged conducted power for NR FR1 and radiated power for NR FR2. In this test, we assumed that Plimit value for NR FR1 is 17.2 dBm when SAR\_design target is 0.75W/Kg, and the Plimit value of FR2 is 7.94 dBm when PD\_design\_target is 4.42W/m2. When NR FR1 is operated, FR2 power would be decreased to maintain TER value. After the average power of LTE is saturated as target power, the average power of FR2 is not decreased any more. As a result, although NR FR1 is turned on, the TER value doesn't increase or decrease. Figure 8.5-2 shows the computed normalized and time-averaged SAR and PD values for NR FR1 and NR FR2, respectively, as well as their sum which is the TER value. We can see that the TER is always under the FCC compliance limit of 1, thus validating the TAS feature in this test case.

TEL: 886-3-327-3456 Page: 66 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

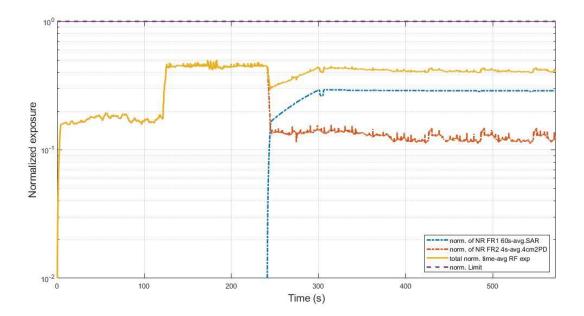


Figure 8.5-2 Total normalized time-average RF exposure

FCC requirement for total RF exposure (normalized)	1.0			
Max total normalized time-averaged RF exposure (yellow curve)	0.502			
Validated				

TEL: 886-3-327-3456 Page: 67 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 10. Conclusions

Samsung S.LSI TAS feature employed in this product has been validated through the conducted power measurement for sub-6, radiated power measurement for FR2 as demonstrated in this report, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0 for all the transmission scenarios. Therefore, the EUT complies with FCC RF exposure requirement.

Report No.: FA4N0917C

# 11. <u>Annex</u>

# 11.1 Test sequence is generated based on below parameters of the DUT:

- 1. Measured maximum power (Pmax)
- 2. Measured Tx power (Plimit) to satisfy SAR Compliance
- 3. Setup time to make SAR Remaining be full
- 4. Do test according to test sequence

## 11.2 Test Sequence A waveform:

Based on the parameters above, the Test Sequence A is generated with two power levels. One is maximum power level and the other is lower power level. The lower power level is defined as 3dB lower value than maximum power level. At first, maximum power level is applied for 80 seconds (SAR\_time\_window x 1.2). After then, lower power level is used until this test is finished.

TEL: 886-3-327-3456 Page: 68 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 11.3 Test Sequence B waveform:

• Based on the parameters above, the Test Type B is generated with pre-defined power levels, which is described in Table 10.3.1.

Report No.: FA4N0917C

Table 10.3.1 Table of test sequence B

Time duration (second)	Power level (dB)	
15	Plimit - 5	
20	Plimit	
20	Plimit + 5	
10	Plimit – 6	
20	Pmax	
15	Plimit	
15	Plimit -7	
20	Pmax	
10	Plimit-5	
15	Plimit	
10	Plimit-6	
20	Plimit + 5	
10	Plimit – 4	
15	Plimit	
10	Plimit – 6	
20	Pmax	
15	Plimit-8	
15	Plimit	
20	Pmax	
10	Plimit – 9	
20	Plimit + 5	
20	Plimit	
15	Plimit – 5	

TEL: 886-3-327-3456 Page: 69 of 70
FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025

# 12. Test Equipment List

Manufacturer	Name of Equipment	Type/Model	Serial Number	Calibration	
				Last Cal.	Due Date
Anritsu	Base Station	MT8821	6201074414	Aug. 20, 2024	Aug. 19, 2025
Anritsu	Base Station	MT8000	6262186342	Oct. 29, 2024	Oct. 28, 2025
Testo	Hygro meter	608-H1	45196600	Oct. 28, 2024	Oct. 27, 2025
Anritsu	Signal Generator	MG3710A	6201502524	Sep. 24, 2024	Sep. 23, 2025
Anritsu	Power Meter	ML2496A	2119003	Jul. 16, 2024	Jul. 15, 2025
Anritsu	Power Sensor	MA2411B	1911333	Jul. 15, 2024	Jul. 14, 2025
Anritsu	Power Sensor	MA2411B	1911334	Jul. 15, 2024	Jul. 14, 2025
Keysight	CATR measurement antenna	SAF-2434231535-328-S1-280-DP	16920-01	Note (1)	
Warison	10-50 GHz Directional Coupler	WCOU-10-50S-10	WR889BMC4B1	Note (1)	
ATM	500M-18GHz Dual Directional Coupler	C122H-10	P610410z-02	Note (1)	
Woken	Attenuator 1	WK0602-XX	N/A	Note (1)	
Woken	Attenuator 2	PE7005-10	N/A	Note (1)	
Woken	Attenuator 3	PE7005- 3	N/A	Note (1)	

Report No.: FA4N0917C

Note <sup>(1)</sup>: Prior to conducted or EIRP power measurement, the path loss from the EUT to the power meter, which includes the RF cable, attenuator and directional coupler, was measured and determined.

TEL: 886-3-327-3456 Page: 70 of 70 FAX: 886-3-328-4978 Issued Date: Apr. 21, 2025